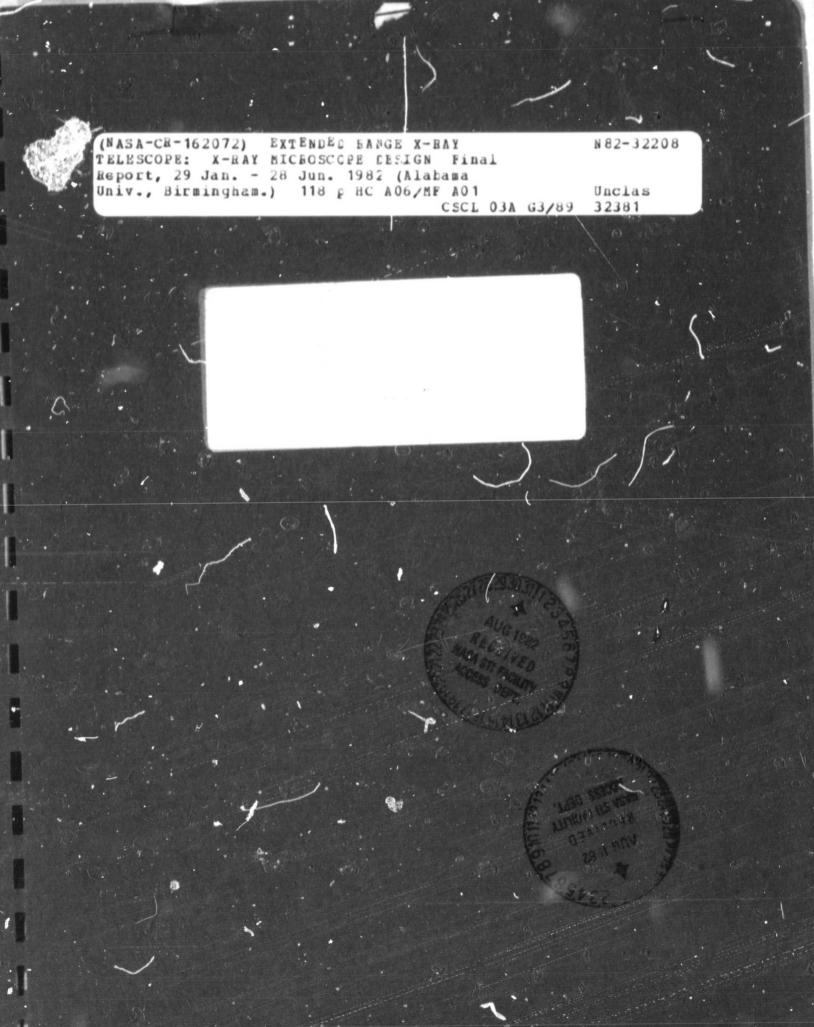
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Extended Range X-Ray Telescope:
X-Ray Microscope Design

PRINCIPAL INVESTIGATOR: D.L.Shealy

CONTRACT NO: NAS8-34728

#### FINAL REPORT

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#### ABSTRACT

A glancing incidence x-ray microscope using a confocal hyperboloid-ellipsoid mirror has been designed to couple optically a Wolter I telescope (SKYLAB, ATM experiment S-056 optics) to a CCD focal plane detector. Both the RMS spot size and the point spread function calculations have been used to evaluate the resolution, defocusing and vignetting effects of the system for microscope focal lengths of 1, 1.5 and 2 meters and for magnifications varying from 2 to 10x. For the specific application with the S-056 telescope, a 2 meter, 8x microscope with a fabrication ratio of the microscope the length to inner diameter hyperboloid-ellipsoid intersection of 2.5 has been designed to be used with a thinned, back illuminated CCD detector array with 320 x 512, 30 micron pixels. The system provides sub-arc second resolution over a field of view of ± 2 arc minutes. By optimizing the microscope mirror lengths, the vignetting effects have been reduced such that the energy transfer from the entrance pupil to the image plane exceeds 20% at 2 arc minutes off axis and 40% at 1 arc minute off axis.

#### TABLE OF CONTENTS

																P	10 E	Ö
ī.	. IN'	rROD	UCTIO	N .	•	• •	•	•	• •	• •	•	•	•	• •		1 .	.s	2
II.	MA'	тнем	ATICA	L AN	ALYS	SIS (	OF E	RXF	tT.									
	В.	RMS	Trac Blur Trac	Circ	cle	Equa	atic	ns	•	•			•	•	•	.16	-	15 18 22
ııı	RES	ULTS			•. •	•	• • ,		•	•	٠		•	•	•	. 23		24
	B. C. D. E.	RMS Vigi Poil	rinsi Spot netti nt Sp imiza rture	Rading Eiread	ius ffec Fur of	Anal ts ctic the	lysi • • on. Mic	s	COL	· ·	•	• •	•	•	•	.30 .35 .39	-	30 34 38 46 49 54
IV	. RE	COMM	ENDAT	IONS	AND	COI	NCLU	sic	ons	•	•	• •	•	•	•	.55	-	56
	AP	PEND	IX A:	X-Ra Pa	ay M aran	licro	osco cs.	pe	Sys	ste •	·m	• •	•	•	•	.57	·.	66
	RE	FERE	NCES.	• •	•	•	• •	• •	• •		•	• •	•		•	. 67	_	68
	FI	GURE	S 1 -	41.											•	- 69	_	113

#### I. INTRODUCTION

There has been considerable progress in glancing incidence x-ray optics during the past two decades, since the first flight of a Wolter I telescope<sup>3</sup>, used to photograph the sun in x-ray, aboard an Aerobee rocket. 17 An interesting summary of activities in the field thru 1978 is given in Ref.18. Subsequent work consisted of putting into orbit the Einstein X-Ray Observatory with a resolution of approximately 4 arc-seconds, 19 which was configured with four nested Wolter I telescopes. Study plans are under way to construct an Advanced X-Ray Astrophysics Facility (AXAF) consisting of six nested Wolter I telescopes with a resolution goal of 0.5 arc-seconds. 20 There have been other quests for high resolution (sub-arc second) in glancing incidence x-ray optics. 11 One such proposal consists of locating a glancing incidence microscope near the focal plane of a Wolter I telescope in order to magnify the image to a CCD array. 11, 21, 22, 23 To date, there has been no such system made. However, the technological capabilities for building glancing incidence x-ray microscopes are available.4,8,9,10 Thus, as part of a proposal to develop an extended range x-ray telescope (ERXRT) funds have been allocated by Marshall Space Flight Center (MSFC) for the

design, analysis, fabrication, and testing of a glancing incidence x-ray microscope to couple the radiation from a Wolter I telescope (£056 optics) to CCD array in order to yield sub-arc second resolution over a field of view of  $\pm$  2 arc mins.

The present report gives (1) the mathematical equations required to ray trace a coupled Wolter I telescope-microscope system; (2) a summary of the intrinsic microscope variables; (3) RMS and point spread function analyses; (4) optimization of the microscope system for coupling the S056 to the CCD array; and (5) the design of the aperture stops. Also, specific conclusions and recommendations of this study are given.

#### II. MATHEMATICAL ANALYSIS OF ERXRT SYSTEM

#### A. Ray Trace Equations for ERXRT

In this section, a summary of the mathematical equations used for the ray trace analysis of the ERXRT will be given. Figure 1\* presents a schematic view of the ERXRT system. The mirror surfaces P and H are the paraboloid and hyperboloid surfaces of the SO56, Wolter I telescope 1-3 of the ERXRT system, and H' and E represent the hyperboloid and ellipsoid mirror surfaces of the converging microscope located in the focal plane of the Wolter I telescope. Using the coordinate system set forth in Ref.1 for the Wolter I telescope it follows that the surface equations for P and H are given by

$$x^{2} = p (2z + p)$$

$$z = \frac{x^{2}}{2p} - \frac{p}{2}$$
(1)

for the paraboloid, and

$$\frac{(z-c)^2}{a^2} - \frac{x^2}{b^2} = 1$$

$$z = c + a \sqrt{1 + \frac{x^2}{b^2}}$$
(2)

\*All Figures (1-41) are grouped together in pages 69 thru 113.

for the hyperboloid. When Eqs.1-2 are used for 3-dimensional applications, X is replaced by  $R = [x^2 + y^2]^{1/2}$ . The mirror surface parameters for the SO56 Wolter I telescope were specified in the "Scope of Work" for this contract and summarized below:

glancing angle,  $\theta m = 0.916^{\circ}$ 

 $X_p \min = 4.792 896 48$ 

 $z_p \min = 149.846 697$ 

 $X_{p}$  max = 4.868 790 7

 $Z_{p}$  max = 154.631 134 5

 $L_p = 4.784 437 7$ 

 $X_h \min = 4.576 677 6$ 

 $X_h$  max = 4.792 896 48

 $z_h$  min = 145.353 53

 $Z_h$  max = 149.846 697

 $L_h = 4.493 167$ 

a = 37.461 664 4

b = 1.695 198 8

c = 37.500 000

p = 0.076 631 56

(3)

where all linear dimensions are in inches.

The microscope surface equations for H' and E in the Wolter I coordinate system are for the hyperboloid,

$$\frac{\left(z-z_{OH}\right)^{2}}{A_{H}^{2}} - \frac{x^{2}}{B_{H}^{2}} = 1$$
(4)

where 
$$Z_{OH} = F_W + C_H$$
 (4a)

$$C_{H} = \frac{F_{m}}{2M} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \frac{\sin(2\theta_{m}')}{\sin(4\theta_{m}-2\theta_{m}')}$$
(4b)

$$A_{H} = \frac{F_{m}}{2M} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \left[ \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}-2\theta_{m}')} - 1 \right]$$
(4c)

$$B_{H}^{2} = C_{H}^{2} - A_{H}^{2}$$
 (4d)

$$\theta_{\rm m}' = \theta_{\rm m} + \frac{1}{4} \sin^{-1} \left[ \frac{\sin(4\theta_{\rm m})}{M} \right]$$
 (4e)

and for the ellipsoid

$$\frac{\left(z - z_{oE}\right)^{2}}{\Lambda_{E}^{2}} + \frac{x^{2}}{B_{E}^{2}} = 1$$
 (5)

where

$$z_{oE} = F_w - F_m + C_E$$
 (5a)

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$$A_{E} = \frac{F_{m}}{2} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \left[ \frac{1 + \sin(4\theta_{m})}{M \sin(4\theta_{m} - 2\theta_{m}')} \right]$$

$$C_{E} = \frac{F_{m}}{2} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \frac{\sin(2\theta_{m}')}{\sin(4\theta_{m} - 2\theta_{m}')}$$
(5b)

$$C_{E} = \frac{F_{m}}{2} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \frac{\sin(2\theta_{m}')}{\sin(4\theta_{m}-2\theta_{m}')}$$
(5c)

$$B_{E}^{2} = A_{E}^{2} - C_{E}^{2} . {(5d)}$$

Referring to Fig. 2 and Appendix A, one has the following interpretations for variables appearing in Eqs.4-5:

 $F_W = 2C$ , focal length of SO56, Wolter I telescope,

 $F_m$  = distance along the optical axis from the object point to the image point of the microscope,

M = magnification of the microscope,

 $\theta m' = glancing angle t the intersection point of$ H' and E surfaces.

The relationships given by Eqs. 4a-e and 5a-d are based on the assumptions that

- (1) F<sub>1</sub> is the focus of H' and E surfaces;
- (2) F2 is the second focus of H' surface, and F2 is also the primary focus of the Wolter I telescope;

- (3) F3 is the second focus of the E surface;
- (4) the glancing angle of ray with H' and E surfaces at the intersection point are equal.

Details of the derivation of Eqs.4-e and 5a-d are given in Appendix A.

The coordinates of the intersection point of the H' and E surfaces are also of interest and are given by

$$X^* = \frac{F_m}{M} \frac{\sin^2(4\theta_m)}{\sin(4\theta_m')} \qquad Z^* = F_w - \frac{F_m}{2M} \frac{\sin(8\theta_m)}{\sin(4\theta_m')}$$
 (6)

It is interesting to note that under the constraints given above, the microscope surfaces are completely specified in terms of  $F_m$ , M, and  $\theta m$ .

Knowing the equations of each surface of the ERXRT system, a ray trace can be done following established methods. 5 A summary of the ray trace equations which have been developed for ERXRT are given below. Assume the incident ray with direction cosines

$$\vec{A}_{0} = -\sin\alpha \hat{i} - \cos\alpha \hat{k}$$
 (7)

strikes the entrance pupil (plane at  $z_0 = z_{p,max}$ ) at the point  $(x_0,y_0,z_0)$  of radius  $R_0 = \left[x_0 + y_0\right]^{-1/2}$ , where  $R_{pmin} \leq R_0 \leq R_{pmax}$ . Then the ray strikes the paraboloid at point  $(x_1,y_1,z_1)$ , which are obtained from the ray trace equations

$$\frac{x_1 - x_0}{z_1(x_1, y_1) = z_0} = \tan \alpha$$
 (8a)

$$y_1 = y_0 \tag{8b}$$

where

$$z_1(x_1,y_1) = \frac{(x_1^2 + y_1^2)}{2p} - \frac{p}{2}$$
, (8c)

$$\frac{\partial z_1}{\partial R_1} = \frac{R_1}{P} \quad . \tag{8d}$$

Solving Eqs.8a-c simultaneously for  $x_1$  gives

$$1 = \frac{1 - [1 - \frac{2 \tan \alpha}{p} (x_0 - z_0 \tan \alpha - \frac{p}{2} \tan \alpha + \frac{\tan \alpha}{2p} y_0)^2]^{1/2}}{(\tan \alpha)/p}$$
 (8e)

The direction cosines of the reflected ray from  $(x_1,y_1,z_1)$  is given by  $^6$ 

$$\vec{A}_{1} = \vec{A}_{0} - 2 \vec{N}_{1} (\vec{A}_{0} - \vec{N}_{1})$$
(9)

where  $\vec{N}_1$  is the unit surface normal to P and is given by

$$\hat{N}_{1} = \frac{-\cos \phi_{1} \frac{\partial z_{1}}{\partial R_{1}} \hat{i} - \sin \phi_{1} \frac{\partial z_{1}}{\partial R_{1}} \hat{j} + \hat{k}}{\left[1 + \left(\frac{\partial z_{1}}{\partial R_{1}}\right)^{2}\right]^{1/2}}$$
(10)

where  $tan \phi_1 = y_1/x_1$ . The ray trace equations from  $P(x_1,y_1,z_1)$  to  $H(x_2,y_2,z_2)$  surface are given by 10 h

$$\frac{x_2 - x_1}{z_2(x_2, y_2) - z_1(x_1, y_1)} = \frac{A_{1x}}{A_{1z}}$$
 (11a)

$$\frac{y_2 - y_1}{x_2 - x_1} = \frac{A_{1y}}{A_{1x}}$$
 (11b)

where  $A_{1x}$ ,  $A_{1y}$ ,  $A_{1z}$  = direction cosines of  $\overline{A}_1$ ,

$$z_2 (x_2, y_2) = C + a \left[1 + \frac{(x_2^2 + y_2^2)}{b^2}\right]^{-1/2}$$
 (11c)

Solving Eqs.lla-c simultaneously for  $x_2$  yields the quadratic equation

$$x_{2}^{2} [A_{1z}^{2} - (\frac{a}{b})^{2} (A_{1x}^{2} + A_{1y}^{2})] + x_{2} [-2x_{1}A_{1z}^{2}]$$

$$+ 2 A_{1x} A_{1z} (z_{1} - C) - 2(\frac{a}{b})^{2} A_{1x} A_{1y} y_{1} + 2(\frac{a}{b})^{2} x_{1}A_{1y}^{2}]$$

$$+ [-x_{1} A_{1z} + (z_{1} - C) A_{1x}]^{2} - (\frac{a}{b})^{2} [b^{2}A_{1x}^{2} + (x_{1} A_{1y} - y_{1}A_{1x})^{2}] = 0.$$
(12)

The appropriate solution of Eq.12 for a Wolter I telescope has a minimum distance from  $(x_1,y_1,z_1)$  to  $(x_2,y_2,z_2)$  where  $y_2 = y_1 + \frac{(x_2 - x_1) A_{1y}}{A_{1x}}$  (12a)  $z_2 = c + a \sqrt{1 + \frac{(x_2^2 + y_2^2)}{b^2}}, \frac{\partial z_2}{\partial R_2} = \frac{aR_2}{b\sqrt{b^2 + R_2^2}}$  (12b) (12a)

$$z_2 = C + a \sqrt{1 + \frac{(x_2^2 + y_2^2)}{b^2}}, \frac{\partial z_2}{\partial R_2} = \frac{aR_2}{b\sqrt{b^2 + R_2^2}}$$
 (12b)

The direction cosines of the ray reflected from H are given

by 
$$\vec{A}_2 = \vec{A}_1 - 2\vec{N}_2 (\vec{A}_1 \cdot \vec{N}_2)$$
 (13)

where  $\vec{N}_2$  is the unit surface normal to H and is given by

$$\hat{N}_{2} = \frac{-\cos \phi_{2} (\partial z_{2}/\partial R_{2}) \hat{i} - \sin \phi_{2} (\partial z_{2}/\partial R_{2}) \hat{j} + \hat{k}}{[1 + (\partial z_{2}/\partial R_{2})^{2}]}$$
(14)

where  $tan \phi_2 = y_2/x_2$ .

The ray intercepts  $(x_3,y_3,z_3)$  on H' of the microscope associated with the reflected ray with direction cosines  $\stackrel{\leftrightarrow}{\Lambda}_2$  from  $H(x_2,y_2,z_2)$  of the Wolter I telescope are obtained by solving the ray trace equations

$$\frac{x_3 - x_2}{z_3(x_3, y_3) - z_2(x_2, y_2)} = \frac{A_{2x}}{A_{2z}}$$
 (15a)

$$\frac{y_3 - y_2}{x_3 - x_2} = \frac{A_{2y}}{A_{2x}}$$
 (15b)

where from Eq. 4 the surface equation of H can be written as  $z_3 = Z_{OH} - A_H \left[ 1 + \frac{x_3^2 + y_3^2}{B_u^2} \right]^{1/2}$ (15c)

where the minus sign is used since  $z_3 < z_{OH}$ . Solving Eqs.15a-c for  $x_3$  yields the quadratic equation

$$x_3^2 = (A_{2z}^2 - (A_{H}^2)^2 + A_{2y}^2) + x_3 = (-2 \times_2 A_{2z}^2) + 2A_{2x}^2 + 2A_{2z}^2 + 2A_{$$

+ 
$$[-x_2A_{2z} + (z_2 - z_{oH})A_{2x}]^2 - (\frac{A_H}{B_H})^2 [B_H^2A_{2x}^2 + (x_2A_{2y}-y_2A_{2x})^2 = 0.$$
(16)

The valid solution of Eq.16 has the larger distance from  $(x_2,y_2,z_2)$  to  $(x_3,y_3,z_3)$  where  $y_3$ ,  $z_3$  are computed from Eqs.15b-c. The direction cosines of the reflected ray from H' are given by

$$\overrightarrow{A}_3 = \overrightarrow{A}_2 - 2\overrightarrow{N}_3(\overrightarrow{A}_2 \cdot \overrightarrow{N}_3)$$
 (17)

where 
$$\hat{N}_{3} = \frac{-\cos\phi_{3} \frac{\partial z_{3}}{\partial R_{3}} \hat{i} - \sin\phi_{3} \frac{\partial z_{3}}{\partial R_{3}} \hat{j} + \hat{k}}{[1 + (\frac{\partial z_{3}}{\partial R_{3}})^{2}]^{1/2}}$$
 (17a)

$$\frac{\partial z_3}{\partial R_3} = \frac{-A_H R_3}{B_H \sqrt{B_H^2 + R_3^2}}$$
 (17b)

$$\tan \phi_3 = \frac{y_3}{x_3} \tag{17c}$$

In similar manner, the ray intercepts  $(x_4,y_4,z_4)$  on E of the microscope follow from the ray trace equations

$$z_{4}(x_{4},y_{4}) - z_{3}(x_{3},y_{3}) = \frac{A_{3x}}{A_{3z}}$$
 (18a)

$$\frac{y_4 - y_3}{x_4 - x_3} = \frac{A_{3y}}{A_{3x}} \tag{18b}$$

where from Eq.5 the surface equation of E can be written as

$$z_4 = z_{OE} + A_E \left[1 - \frac{x_4^2 + y_4^2}{B_E^2}\right]^{1/2}$$
 (18c)

The plus(+) sign is used in Eq.18c when the left half of the ellipsoid corresponds to the mirror surface E, and the minus(-) sign is used in Eq.18c when the right half of the ellipsoid corresponds to the mirror surface E. That is, if

$$z * < z_{OE}$$
, Then  $z_4 = z_{OE} - A_E [1 - (x_4^2)/B_E^2]^{1/2}$ , (19a)

$$z + z_{oE}$$
, Then  $z_4 = z_{oE} + A_E [1 - (x_4^2)/B_E^2]^{1/2}$ . (19b)

It is also possible that if z\* is slightly larger than  $z_{OE}$ , then it would be necessary to change signs in Eq.18c as one traced rays over the entrance pupil. Therefore, it is interesting to know for what physical conditions

$$z \stackrel{*}{=} z_{\text{oE}}$$
. (20a)

Simplifying Eq.20a from Eqs.5a, 5c, and 6 yields an equation for M( $\theta$ m) when Eq.20a holds:

$$\sin (80m) \sin (40m - 20m) - 2M \sin (40m) \sin (40m - 20m)$$
  
+ M sin (40m) sin (20m) = 0 (20b)

where  $\theta m'$  is given by Eq.4e. A solution of Eq.20b is given

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$$M = \frac{\sin (40m)}{\sin (40m)} = \overline{M} . \tag{20}$$

It is also interesting to note that the angle the tangent to E makes with respect to the Z-axis is given by

$$\gamma_{\rm E} = 40 \,\mathrm{m} - 30 \,\mathrm{m}$$
 (20c)

and  $Y_{\rm E}$  = () implies that M is given by Eq.20. For the SO56, Wolter I telescope 0m = 0.916° and

$$\overline{M} = 2.998.$$
 (20d)

to summarize these results:

(1) For 
$$M < \overline{M}$$
,  $z_{oE} > z^{-\frac{M}{2}}$ , and 
$$z_4 = z_{oE} - A_E \left[1 - (x_4^2)/B_E^2\right]^{1/2}$$
; (21a)

(2) For 
$$M > \overline{M}$$
,  $z_{OE} < z^*$ , and 
$$z_{4} = z_{OE} + A_{E} \left[1 - (x_{4}^{2})/B_{E}^{2}\right]^{1/2}.$$
 (21b)

Now return to the ray trace equations of the ERXRT.

Solving Eqs.18a-c for  $\times_{4}$  yields the quadratic equation

$$x_{4}^{2} \left[ A_{3z}^{2} + (A_{E} / B_{E})^{2} (A_{3x}^{2} + A_{3y}^{2}) \right] + x_{4} \left[ -2x_{3} A_{3z}^{2} + 2 A_{3x} A_{3z} (z_{3} - z_{oE}) + 2 (A_{E} / B_{E})^{2} A_{3x} A_{3y} y_{3} \right]$$

$$- 2 (A_{E} / B_{E})^{2} x_{3} A_{3y}^{2} + \left[ -x_{3} A_{3z} + (z_{3} - z_{oE}) A_{3x} \right]^{2}$$

$$+ (A_{E} / B_{E})^{2} \left[ -B_{E}^{2} A_{3x}^{2} + (x_{3} A_{3y} - y_{3} A_{3x})^{2} \right] = 0.$$
(22)

where  $y_4$ ,  $z_4$  are obtained from Eqs.18b-c. The direction cosines of the reflected ray from E are given by

$$\vec{A}_4 = \vec{A}_3 - 2 \vec{N}_4 (\vec{A}_3 \cdot \vec{N}_4)$$
 (23)

$$\vec{N}_{4} = \frac{-\cos\phi_{4} \frac{\partial z_{4}}{\partial R_{4}} \hat{i} - \sin\phi_{4} \frac{\partial z_{4}}{\partial R_{4}} \hat{j} + \hat{k}}{\left[1 + \left(\frac{R_{4}}{R_{4}}\right)^{2}\right]^{1/2}}$$
(23a)

$$\frac{\partial z_4}{\partial R_4} = \mp A_E R_4 / (B_E \cdot (B_E^2 - R_4^2)^{1/2}) , \text{ for } z_4 \stackrel{>}{<} z_{oE} . \quad (23b)$$

$$\tan \phi_4 = \frac{y_4}{x_4}$$
 (23c)

Then the ray intercepts with the focal plane are given by

$$z_{5} = F_{w} - F_{m} + \Delta Z$$

$$x_{5} = x_{4} + (z_{5} - z_{4}) A_{4x} / A_{4z}$$

$$y_{5} = y_{4} + (z_{5} - z_{4}) A_{4y} / A_{4z}$$
(24)

where  $\Delta\,Z$  corresponds to the displacement of the image plane from the axial focal point.

#### B. RMS Blur Circle Equations

Since the ray intercepts with the image plane result from a complicated, aberrated emerging wavefront for off-axis incident radiation, it is conventional to consider that the ray intercepts are randomly distributed over the image plane and to use statistical methods for analyzing the ray intercepts with the image plane, or spot diagram.

The ray trace equation is used to calculate the root mean square deviation around the average image point that represents the ray intercepts over the image plane for all rays passing through the ERXRT over the whole aperture, i.e., the RMS blur radius or RMS of the spot diagram. 7

Since the spot diagram for non-zero, off-axis angles has no rotational symmetry about any axis parallel to the optical axis, it is necessary to define in some way how to compute the radius of the spot diagram.

Suppose (X', Y') represents the coordinates of the intersection point of an arbitrary ray striking the nominal focal plane, Z' = 0. Then the ray coordinates on the optimum image plane are given by

$$X_{I} = X'$$
 (i)  $+ Z_{min}^{A}$  (i) (25a)

$$Y_{I} = Y' \quad (i) + Z_{min}^{B} \quad (i)$$
 (25b)

where  $A_{(i)} = A_{4x}/A_{4z}$ ,  $B_{(i)} = A_{4y}/A_{4z}$ , and  $A_{4}$  is the unit vector of the direction of the reflected ray toward the focal plane.  $Z_{min}$  is the distance from the nominal image plane to the optimum plane.

The average over N rays of Eqs. 25a-b is given as

$$\overline{X}_{I} = X' + Z_{min} \overline{A}$$

$$\overline{Y}_{T} = \overline{Y}' + Z_{\min} \overline{B}$$
 (26)

where

$$\overline{X}_{I} = \frac{1}{N} \sum_{i=1}^{N} X_{I}$$
 (i) ,  $\overline{Y}_{I} = \frac{1}{N} \sum_{i=1}^{N} \overline{Y}$  (i)

$$\overline{X}' = \frac{1}{N} \sum_{i=1}^{N} X'$$
 (i)  $\overline{Y}' = \frac{1}{N} \sum_{i=1}^{N} Y'$  (i)

$$\overline{A} = \frac{1}{N} \sum_{i=1}^{N} A_{3x}(i)/A_{3z}(i)$$
 , and

$$\overline{B} = \frac{1}{N} \sum_{i=1}^{N} A_{3y}(i) / A_{3z}(i) .$$

If one defines the least square errors,  $e^2$ , as

$$e^{2}(\mathbb{Z}_{\min}) = \frac{1}{N} \sum_{i=1}^{N} \left[ (X_{I}(i) - \overline{X}_{I})^{2} + (Y_{I}(i) - \overline{Y}_{I})^{2} \right], \qquad (27)$$

Eq.27 can be rearranged as

$$e^2(Z_{min}) = a Z_{min}^2 + b Z_{min} + c$$
, (28)

where

I

I

$$a = \frac{1}{N} \sum_{i=1}^{N} (A_{(i)}^2 + B_{(i)}^2) - \overline{A}^2 - \overline{B}^2$$

$$b = \frac{2}{N} \sum_{i=1}^{N} (X' (i) A_{(i)} + Y' (i) B_{(i)}) - 2(\overline{X}'\overline{A} + \overline{Y}'\overline{B})$$

$$c = \frac{1}{N} \sum_{i=1}^{N} (X'^{2}_{(i)} + Y'^{2}_{(i)}) - \overline{X}'^{2} - \overline{Y}'^{2}$$

(e $^2$ ) has a minimum with respect to  $z_{\text{min}}$  when

$$\frac{\partial(e^2)}{\partial Z_{\min}} = 0 = 2 Z_{\min} a + b$$
 (29)

or

$$z_{min} = -b/a$$
.

Thus, the RMS of the spot radius on  $\mathbf{Z}_{\min}$  is given by

(RMS) 
$$z_{min} = \sqrt{e^2 (z_{min})}$$
 (30)

and on 
$$Z' = 0$$
, RMS =  $\sqrt{c}$ . (31)

#### C. Ray Trace Code

In sections II.A-B, the mathematical equations to be used in the ray trace analysis of the ERXRT system have been presented. A brief discussion of the ray trace code used in this study is given in this section. The computer ray trace program can be broken down into the following parts:

 Define input constants for ERXRT system. For Wolter I telescope (Eq.3):

a, b, c, p,  $\theta m$ ,  $L_p$ ,  $L_H$ ,  $X_{pmin} = X_{Hmax}$ ,

Zpmin=ZHmax, Xpmax, Zpmax, XHmin, ZHmin. For converging microscope:

 $F_m (= 1, 1.5, 2 m.)$ 

M = 2, 3, 4, 5, 6, 6.5, 7, 8

LH', LE (varied from minimum to

maximum values)

where  $L_p$ ,  $L_H$ ,  $L_H$ ,  $L_E$  are the axial lengths of the respective surfaces and are measured from the intersection point of each subscription.

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- 2. Assign direction cosines to an incident ray. It has been assumed that the incident ray is in the X-Z plane and makes an angle  $\alpha$  with respect to the Z axis. The angle  $\alpha$  assumes values 0, 0.25, 0.50, ..., 2.5 arc-min.
- 3. Set up a grid on the entrance pupil, which is an imaginary plane perpendicular to the optical axis located at  $Z_{pmax}$ , such that each ray will pass thru equal areas on the entrance pupil. For RMS calculations, a rectilinear grid is used where 3,844 rays pass thru the ERXRT system for  $\alpha$ =0. For point spread function (PSF) calculations, polar coordinates  $R_0$ ,  $\phi$  on the entrance pupil are used where

$$Φ_{o} = 0$$
,  $ΔΦ$ ,  $2ΔΦ$ , ...  $180^{0} - ΔΦ$ 
 $ΔΦ = 180^{0} / (NPHO-1)$ 
 $R_{o} = R_{o1} (≡ X_{pmin})$ ,  $R_{o2} (≡ [R_{o1} + Δ]^{1/2})$ ,

...,  $R_{oN} (≡ [R_{o1}^{2} + (NRO-1) Δ]^{1/2} X_{pmax})$ 
 $Δ = (X_{pmax} - X_{pmin}^{2}) / (NRO-1)$ 
 $NPHO = 3000$ 
 $NRO = 100$ 

The reflection symmetry of the ERXRT system about the X-Z plane is used to obtain the intercepts of the rays, which would have passed thru the entrance pupil for  $\phi_0 = 180^\circ$  to  $360^\circ$ . Thus, 600,000 rays have been used to compute the PSF of the ERXRT system.

- 4. For each field angle α, a ray is traced thru each grid point on the entrance pupil, using the equations outlined in Section II.A. For a given ray, it is necessary that this ray intercepts each mirror surface of the ERXRT system of the specified lengths before arriving at the image plane and being used in RMS and PSF calculations. For each field angle, the rays which actually intercept the image plane are counted for the vignetting study.
- 5. After completing the ray trace for all grid points at a given field angle, the RMS blur circle radius is evaluated from the equations in Section II.B for a series of image planes, such that defocusing effects can be studied. Also, the optimum image surface, i.e., the loci of image points with minimum RMS blur circle radius, is computed.

6. The PSF is evaluated by setting up a NXG by NYG grid on the image surface. For each field angle, the ray intercepts with the image plane are sorted into different image grid locations. The number of rays per image plane cell time the element of area ΔA (=collecting area divided by the total number of rays incident upon the telescope) is a measure of the PSF. The size of the image plane grid is chosen such that all rays will be incident within the image grid. Generally, NXG = NYG = 41 has been used for the number of grid points.

#### III. RESULTS

In this chapter the results of the ray trace analysis of the ERXRT system are presented. Results have been obtained for the microscope focal lengths,  $F_m$ , to have values of 1, 1.5, and 2 meters and for the microscope magnification, M, to have values of 2, 3, 4, 5, 6, 6.5, 7, 8x. The field angle,  $\alpha$ , has assumed values of 0, .25, .5, ..., 2.5 arc-mins where it has been recognized that the measured resolution of the SO56, Wolter I optics varies from 0.75 arc-sec on-axis to approximately 1 arc-sec over a field of view of  $_+$  2.5 arc-mins.

The overriding objective in developing this chapter is to present the performance data on a wide range of coupled Wolter I (SO56) - microscope systems such that a microscope configuration can be identified for optimum coupling between the SO56 telescope and the CCD detecter array located in the focal plane of the microscope. Input and analysis of interim data by the MSFC ERXRT design team and the MSFC principal investigator have been instrumental in restricting the range of  $F_{\mathfrak{m}}$  and M variables such that recommendations on a finalized mirror design to be used in the fabrication effort can be made.

Specific data presented in this chapter will

include: (1) in Section A, a discussion of intrinsic microscope variables, such as the mirror surface parameters, the glancing angle, 0 m', and the intersection diameter as a function of M; (2) in Section B, an evaluation of the RMS spot radius versus the field angle differant values o f Μ, Fm, and image plane displacements, A Z, from the nominal location; (3) in Section C, an analysis of vignetting effects thru plots of the percent energy loss versus the lengths of the microscope hyperboloid and ellipsoid mirror surfaces for selected field angles; and a comparison of the percent energy loss and RMS spot radius; (4) in Section D, a study of the point spread function in the meridional and sagittal plane versus image plane coordinates for selected field angle, magnification, focal length of the microscope and hyperboloid and ellipsoid lengths; (5) in Section E, optimization of the microscope mirror lengths for coupling the S056 telescope to the CCD detector array for the ERXRT and (6) in Section E, a design of appropriate system; stops for the selected mirror design to vignette unwanted radiation and prevent it from striking the In Chapter IV, conclusions and recommendations detector. based on the data given in this chapter will be presented.

#### A. Intrinsic Microscope Variables

As indicated in Chapter II, the microscope surface parameters (AH, BH, CH, ZOH, AE, BE, CE, ZOE), which are given by Eqs.4a-d, 5a-d, are functions of  $F_{m}$  and M, when the Wolter I telescope configuration is fixed. microscope systems of interest for use in the ERXRT system  $(F_m=1, 1.5, 2 \text{ meters and } M=5, 6, 6.5, 7, 8x)$ , Tables 1,2,3 present the surface parameters, minimum hyperboloid and ellipsoid lengths, and the X-Z plane intersection coordinates. It should be noted that LH' and LE given in Tables 1-3 are the minimum axial lengths of the hyperboloid and ellipsoid microscope mirror surfaces such that all the radiation incident upon the SO56, Wolter I telescope, which is parallel to the optical axis, will be reflected by the microscope to the ERXRT focal point. Furthermore, it is interesting to note, that the K value for the microscopes defined by Tables 1-3 are given by

M	<u> </u>
5	0.808
6	0.831
6.5	0.840
7	0.848
8	0.864

where these results are independent of the value of  $\mathbf{F}_{\mathbf{m}}$ 

TABLE 1: MICROSCOPE SURFACE PARAMETERS

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E. S. S. S. S. S.

FOR  $F_{\rm m} = 1$  meter

# MAGNIFICATION (x)

œ	7.136467	0.302071	7.142857	197.642857	0.597003	57.149244	0.854385	57.142857	147.642857	0.627062	0.710240	179.408767
<b>r~</b>	8.326030	0.348807	8.33333	198.833333	0.661688	58.340633	0.922855	58.333333	148.833333	0.693805	0.799049	178.021907
6.5	9,083044	0.378073	606060*6	199,590909	0.699430	59.098770	0.96390	59,090909	149.590909	0.732619	0.852338	177.189735
9	9.991479	0.412722	10.0	200.50	0.741581	60.008516	1.010959	0.09	150.50	0.775851	0.913244	176.238628
<b>'</b>	12.489775	0.505495	12.50	203.03	0.842359	62.510220	1.130320	62.50	153.03	0.878679	1.065524	173.860599
CM.	A	B H	J=	Z <sub>OH</sub>	, H <sub>1</sub>	AE	В Ш	CE	Z <sub>0E</sub>	+	**	*7

<sup>†</sup>Minimum axial lengths of microscope mirror surfaces required to reflect on axis radiation incident upon the Wolter I telescope towards the focal point of the ERXRI system.  $L_H$  and  $L_E$  are measured from the microscope intersection point  $(x^*, Z^*)$ .

TABLE 2: MICROSCOPE SURFACE PARAMETERS

I.

1

B ....E. . 3

FOR  $F_m = 1.5$  meter.

## MAGNIFICATION (x)

ω	10,704701	0.453106	10.714286	201.214286	0.895504	85.723866	1.281577	85.714286	126.214286	0.940592	1.065360	173.863150
7	12,489045	0.523210	12.50	203.0	0.992532	87.510949	1.384283	87.50	128.0	1.040707	1.198574	171.782861
6.5	13.624566	0.567109	13,636363	204.136363	1.049145	88.648155	1.445850	88, 636363	129.126363	1.098929	1.278508	170.534603
9	14.987219	0.619083	15.0	205.50	1.112371	90.012775	1.516438	0.06	130.50	1.163777	1.369866	169.107943
ß	18.734662	0.758242	18.750	209.250	1.263538	93.765330	1.695481	93.750	134.250	1.318018	1.598285	165.540899
<b>.</b>	AH	. m	"ی	H0Z	·	, M	, E	الى ا	$\frac{1}{2}$	+    -	¹ *×	*Z

 $L_{H}^{\prime}$  and  $L_{E}$ +Minimum axial lengths of microscope mirror surfaces required to reflect on axis radiation incident upon the Wolter I telescope towards the focal point of the ERXRI system.  $L_{\rm H}^{\prime}$  and are measured from the microscope intersection point  $\{X^{\star}, Z^{\star}\}$ .

TABLE 3. MICROSCOPE SURFACE PARAMETERS FOR  $F_{\rm m} = 2~{\rm meter.}$ 

( )	3
MACHITACATION	PINCE I CALLON

ω	14.272934	0.604141	14.285714	204.785714	1.194006	114.298488	1.703770	114.285714	104.785714	1.254123	1.420480	168.317533
7	16.652060	0.697613	16.666667	207.166667	1.323375	116.681266	1.845711	116.666667	107.166667	1.387609	1.598099	165.543814
<b>0</b>	18.166088	0.756146	18.181818	208.681818	1.3988602	118.197540	1.927801	118.181818	108,681818	1.46524	1.704677	163.879471
9	19,982959	0.825444	20.0	210.50	1,4831618	120.017033	2.021917	120.0	110.50	1.551702	1.826487	161.977257
S	24.979550	1.010989	25.0	215.50	1.684717	125.020440	2.260641	125.0	115.50	1.75736	2.131047	157.227199
<b>.</b>	A	: <sub>4</sub>	تی ت	HU <sub>Z</sub>	, <sup>1</sup>	. A <sub>T</sub>	بع با ر	ىلى د	Z <sub>OF</sub>	, + - u	, *X	*Z

<sup>&</sup>lt;sup>+</sup>Minimum axial lengths of microscope mirror surfaces required to reflect on axis radiation incident upon the Wolter I telescope towards the focal point of the ERXRI system.  $L_{\rm H}^{\prime}$  and  $L_{\rm E}$  are measured from the microscope intersection point (X\*,  $Z^{\star}$ ).

within the range of consideration and K is defined by

$$\frac{K = L_{H}' + L_{E}}{2X^{*}}.$$

Previous x-ray microscope systems, which have been fabricated, have had K values ranging from 0.98(ref.8) to 1.87(ref.9). Current manufacturing techniques have suggested that typical midplane diameters for x-ray microscopes are in the range of 10 to 40 mm and the element lengths can be up to double these dimensions. 10 For the ERXRT system a goal of K=2.5 has been set. The effects of increasing the hyperboloid and ellipsoid length over the minimum lengths given in Table 1-3 will be reported in Section C.

In Fig.3, the midplane diameters of the ERXRT microscope system are displayed as a function of the magnification for  $F_m$  = 1, 1.5, 2 meters, where Eq.6 was used to compute these results. It should be noted that for  $F_m$  = 2 meters and M = 5 and 8x, the midplane diameter varied from 42mm to 28mm, respectively, which are well within the range of manufactorable systems. Figure 4 presents the glancing angle at the intersection point of the microscope system versus the magnification for an axis radiation incident upon the SOS6, Wolter I telescope. Note from Eq.4e that  $\theta_m$  is only a function of the glancing

angle,  $\theta_{\rm m}$ , at the intersection point of the Wolter I telescope and the magnification, M, of the microscope. For magnifications in the range of 5 to 8x,  $\theta_{\rm m}$ ' varies from 1.10 to 1.03 degrees, respectively. Figures 5 and 6 give the glancing angles  $\theta_{\rm H}$ ' and  $\theta_{\rm E}$  as a function of the Wolter I entrance pupil radius  $R_{\rm O}$  for the magnifications M = 5, 6, 6.5, 7, 8 and for on axis radiation incident upon ERXRT system. The results presented in Figs.5 and 6 have been obtained from the ray trace analysis by computing the angle between the ray vectors  $\vec{A}_2$ ,  $\vec{A}_3$  and the surface tangent vectors to H' and E, respectively. Although  $\theta_{\rm H}$ ' is a stronger function of  $R_{\rm O}$  than  $\theta_{\rm E}$ ; both  $\theta_{\rm H}$ ' and  $\theta_{\rm E}$  are within an acceptable range to achieve high reflectivities from the microscope mirror surfaces for the wavelengths under consideration for the ERXRT system.

#### B. RMS Spot Radius Analysis

In this section, the RMS spot radius data versus the field angle for different values of M,  $F_m$ , the displacement  $\Delta Z$  of a flat image plane from the nominal position will be presented and discussed. The purpose of this analysis is to establish an upper bound on resolution of ERXRT as measured by RMS as a function of  $F_m$  and M of the microscope

subsystem. Also, defocusing effects will be analyzed.

Figures 7-9 give the RMS spot radius as a function of the field angle for the ERXRT system with the microscope image to object distance  $F_{\rm m}$  equal to 1, 1.5, 2m and the magnification M varying from 2 to 8x. The general trends are that the RMS for a given field angle decreases with increasing values of  $F_m$  for constant M and that the RMS for a given field angle increases with increasing M for a constant  $F_m$ . For the calculations given in Figs. 7-8, the image plane has the nominal location at F3 (see Fig.2), and the microscope mirror lengths LH', LE have the minimum lengths given in Tables 1-3. Figure 10 plots the RMS versus magnification for  $F_{m} = 1.2m$  at a field angle of 2.5 arc-mins. It follows that the RMS at the full field is a linear function of the magnification. Also, for  $F_{m} = lm$ , the RMS is a stronger function of the magnification than for  $F_m = 2m$ .

By removing the constraints that the microscope mirror surfaces have, the minimum lengths, the RMS versus field angle over the nominal image plane for  $F_{\rm m}=1.5{\rm m}$  were calculated for maximum mirror lengths and are presented in Fig.11. The actual lengths of the microscope mirror surfaces used in Fig.11 are given in Table 4.

TABLE 4: Lengths of H', E Mirror Surfaces of Microscope for  $F_m = 150$  cm used in Fig.10.

M	LH (cm)	LE (cm)	K
5	9.22529	5,71551	4.67
6	9.35261	4.95065	5.22
7	9.46021	4.33431	5.75
8	9.69431	3.87089	6.37

It is clear after comparing the RMS for a given field angle and magnification between Figs.8 and 11 that there are significant losses in resolution by increasing the mirror However, there is a compensating effect of an increased through put of energy from the entrance pupil to the image plane, which will be discussed more fully in For an additional comparison of the RMS with Section C. minimum and maximum mirror length systems, Fig. 12 gives the RMS versus the field angle for  $F_m = 1m$  and M = 6x. Fig. 12, it follows that for field angles greater than 0.5 arc-mins the microscope mirror lengths have a significant influence on the RMS of the system. Optimization of the microscope mirror lengths for the S056 telescope and CCD detector array to be used in the ERXRT system will be discussed in Section E.

It is generally known that resolution of an optical system can be improved by defocusing the image surface from the nominal location. As a lower limit for the RMS, Figures 13-15 present the RMS versus the field angle on the optimum curved image surface for  $F_{\rm m}=1$ , 1.5, 2m using the minimum microscope mirror lengths. The optimum image surface is a concave surface facing the ERXRT system where the displacement  $\Delta Z$  from the nominal image plane as a function of the field angle is given by Figs.16-18, corresponding to Figs.13-15. It is recognized that it is not practical to make a curved image surface for the ERXRT system, but the information given in Figs.13-18 is useful in evaluating the depth of field and defocusing tolerances of the ERXRT system.

For specific defocusing results, Figure 19 gives the RMS versus the field angle over different image planes. Each image plane has been displaced toward the microscope from the nominal focal point  $F_3$  (see Fig.2) by an amount  $\Delta Z$ . The information presented in Fig.19 is used by setting an upper limit for an axis ( $\alpha = 0^{\circ}$ ) RMS, such as, one (1) arc-sec. Then, by using the image plane which has been defocused 6mm towards the microscope, an RMS of less than one (1) arc-sec will be maintained up to 1.5 arc-mins of

field. By normalizing the RMS by the RMS at  $\alpha$  = 2 arc-mins on the nominal image plane ( $\Delta Z$  = 0), the RMS data given in Fig.19 has been replotted in Fig.20 as a function of  $\Delta Z$  for  $\alpha$  = 0, 1, 1.75, 2 arc-mins. Figure 20 is useful in extrapolating the defocusing information presented in Fig.19 to ERXRT systems with different values of F<sub>m</sub>, M, or K. This will be considered in more detail in Section E.

As a closing comment on defocusing, a limited evaluation of the effect on the RMS over the image plane has been carried out when the microscope is shifted along the symmetry axis towards the S056 telescope by a small amount  $\Delta Z_m$ . In these calculations, the image plane remained at original location F3. For the system  $F_m=1m$ , M=5x, K=2, the RMS increased by 2% at the field angle of 1.5 arc-mins when  $\Delta Z_m=2mm$ . This suggests the microscope should be positioned at the design location to within an axial accuracy of 2mm. The effects of lateral displacements or tilts of the microscope from the design position have not been considered in this study.

### C. Vignetting Effects

In this section vignetting effects of the ERXRT system will be considered. As indicated in Fig. 12, there are large increases in the RMS at field angles greater than 0.5 arc-mins when the microscope mirror lengths are increased from their minimum lengths. However, there is a compensating effect of an increased transmission of energy for the ERXRT system when the mirror lengths are increased. Figure 21 gives the percent energy loss due to vignetting versus the field angle for  $F_m = 1m$  and for minimum and maximum microscope mirror lengths. In order to more carefully evaluate the effect of increasing the microscope mirror lengths on the percent energy loss, Figures 22a-c give the percent energy loss versus the microscope hyperboloid length for  $F_m = 1$ , 1.5m and  $\alpha = 1$  arc-min. Figures 23a-c give the percent energy loss versus the ellipsoid length. Comparing Figs. 22-23, one concludes that the percent energy loss is a stronger function of the hyperboloid length than of the ellipsoid length. to compare the two effects of percent of energy loss and increase in RMS, that is, the loss of resolution when the mirror surfaces are made longer, refer to Figs. 24-25 for the ERXRT system  $F_m = 1m$ , M = 5x at  $\alpha = 1$  arc-min. Figures 24-25 show that the percent energy loss and the gain in resolution, that is, reduction in RMS, are reciprocal effects and that the hyperboloid length has a stronger effect on both the energy loss and resolution than the ellipsoid length. The mirror lengths for the crossing point of the energy loss and RMS curves in Figs.24-25 may be considered to a first approximation as optimum mirror lengths for the purpose of balancing the competing energy loss - RMS effects. However, matching of the S056/ERXRT system imaging characteristics with the detector capabilities and the K values of the microscope system must be considered before suitable optimization of the mirror lengths can be effective.

After matching the ERXRT system imaging capabilities with the CCD detector resolution and considering the mission objectives for the field of view, the MSFC ERXRT Design Team selected the microscope parameters  $F_m=2m$  and M=8x for fabrication. Therefore, more detailed vignetting information for the selected microscope will be given at the field angles of 1 and 2 arc-mins. Figures 26-27 present the RMS and percent energy loss versus  $L_H$  and  $L_E$  for K=1.5. Similar results for K=2.5 are given in Figs.28-29. It follows from Figs.26-27 that maximum

transmittance (energy transmitted thru the ERXRT system = 1 - energy loss) and maximum RMS occurs for  $L_{H}$ ' =  $L_{E}$  = 2.1cm at  $\alpha$  = 1, 2 arc-min for K = 1.5,  $F_{m}$  = 2m, M = 8x. Also, from Figs.28-29 it follows that the maximum transmittance and RMS occurs when  $L_{H}$ ' = 3.7cm,  $L_{E}$  = 3.30 for  $\alpha$  = 1 arc-min and  $L_{H}$ ' = 3.8cm,  $L_{E}$  = 3.2cm when  $\alpha$  = 2 arc-min for K = 2.5,  $F_{m}$  = 2m, M = 8x. Further consideration of the optimization of the mirror lengths will be presented in Section E.

In concluding the present discussion on vignetting effects, it is interesting to note the dependence of the RMS and transmittance on K for a given field angle. Figure 30 gives the RMS versus K for  $\alpha=2$  arc-mins,  $F_m=2m$ , M=8x. Figure 30 further illustrates that there can be large variations in the RMS for a given K as a result of varying the microscope mirror lengths. Figure 31 presents the transmittance versus K for  $\alpha=2$  arc-mins,  $F_m=2m$ , M=8x. The percentage variations in the transmittance resulting from changing the mirror lengths at a constant K are not as great as those presented in Fig.30. Before an effectively optimizing the mirror lengths, it is necessary to analyze the behavior of the point spread function (PSF) and compare the full width half maximum (FWHM) of the PSF in the

meridional and sagittal directions with the RMS spot radius.

#### D. Point Spread Function

It is generally recognized in glancing incidence x-ray optics11 that the RMS spot radius does not provide a quantitative measure of resolution. Experience has shown that the full width half maximum (FWHM) of the point spread function (PSF) is more in keeping with the measured resolution of glancing incidence x-ray optical systems. 12-13 Using conventional ray tracing techniques, PSF calculations require several orders of magnitude more rays to be traced than RMS calculations. There is a need for new theoretical developments in glancing incidence x-ray optics such that the PSF can readily be evaluated. Interesting prospects are in progress for applying the analytical flux flow equation 14 to glancing incidence systems and for developing a general aberration theory for qlancing incidence systems which would not be limited to the intersection zone of such optical systems. 15-16 However, in this study only conventional ray tracing methods have been used.

In this section the results for the PSF of the ERXRT system defined by  $F_m=2m$ , M=8x, K=2.5,  $L_{H}^{\prime}=3.3cm$ ,  $L_{E}=3.7cm$  will be presented. Then, by comparing the RMS data to the PSF data for this ERXRT system a resolution scaling

factor is obtained. Using these results, optimization of the microscope lengths for the fabrication effort will be presented in Section E.

Tables 5, 6, 7 give the ray distribution (number of rays per image plane cell) over half of the X-Y image plane (Y>/0) for the field angles  $\alpha=0.5$ , 1, 2 arc-minutes off axis. Also, the number of rays with constant X and Y coordinates, partial sums of rays, and percent of total rays at given distance from the axis are given. The point spread function (PSF) is computed by multiplying the number of rays per image plane cell times the area per ray at the entrance pupil,  $\Delta A = 2.50203 \times 10^{-5} \text{cm}^2$ , and the incident x-ray flux density at the system.

The meridional line spread function has been evaluated from data in Tables 5-7 and is plotted in Figs.32, 33, 34 for the field angles  $\alpha=0.5$ , 1, 2 arc-minutes. It should be noted that Figs.32-34 are in fact a plot of the " IYG" data in Tables 5-7 versus XG. Since the image plane ray distributions are strongly aberrated, it is not useful to plot analogous graphs to Figs.32-34 in the sagittal direction. Rather, Figures 35, 36, 37 represents slices of the point spread function at constant X. The wedges in the center of the sagittal line

TABLE 5

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= 2m, M = 8x,  $L_H$ ' = 3.3cm,  $L_E$  = 3.7cm. arc-secs. The efficance pupil area for Ray discribution over half xy image plane (y>/0) for  $\alpha=0.5$  arc-min, F=2m, M=Also, the image plane grid is  $\Delta XG=0.013534$  arc-secs and  $\Delta YG=0.01015$  arc-secs. each ray is  $\Delta A=2.50203x10^{-5}$  cm<sup>2</sup>.

	8	180	2.8	52.3	67.75	0.03	2		67.6	84.6	81-31	17.8	24.0	63.6	663	430	8.65	2	0 0	200	a a	8:4	07/	78.6	25.50	17.6	100	12.7	7						
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ij The entrance pupil area for 47. = 円 CRELON 100.092 98087 855782 84213 81467 78740 13277 70 767 105.500 95389 76029 67.594 217,69 15.419 52 257 54 855 57245 43091  $L_{\rm H}' = 3.3$ cm, 2699 50 60 0 1423 13 17 2809 1086 26 33 2582 3402 18 435 2549 1001 2310 2873 988€ 3612 3115 4805 5707 7605 1800 4909 00 456 = 2m, M = 8x,29.0 347 304 304 360 342 333 356 335 1900 4147 349 335 308 324 132 668 286 211.6 Also, the image plane grid is  $\Delta XG = 0.05075$  arc-secs and  $\Delta YG = 0.05955$  arc-secs. 430 396 138 204 1321 8.8 8.7 295 305 E Sec HH; 7433 1282 300 A ROS l arc-minute, 3.8 7.4 11.0 14.5 18.1 21.6 25.3 29.0 33.1 37.5 42.6 42.1 57.1 65.9 73.8 433 84% 266 310 299 465 354 156 366 38 054 964 470 578 825 391 127 SOZ ich 25.73 33.7 339 , Sp. (2) 285 237 286 287 146 319 343 306 387 18 33/ 165 542 566 18 4339 4813 5477 4526 8779 1523,00 484 52.2 143 11 256 1901 026 160 (6285A) 성 plane (y>/0) for 691 Incom ħ'n Ó 100 36 877 40/1 1165 234 1451 1375 image 3214 3773 3837 8843 <u>1</u> ख<sub>्यं</sub> 606 Ray distribution over half xy  $= 2.502\widetilde{0}3x10-5$ 15831 343 1290 2160 ŗ ABU! 1329 1 1000 J 3272 2979 1-1 ĺ 190/01 2048 2054 each ray is AA - Kar 2048 1054 0 6.1 (C m) 4516 .4512. 13604 4524 5056 ZEAn 6054 27.5 LCSh. 4530 1054 Cabh 4475 73 th 4464 09/1 9566 CShin. 4425 とかかっ かだっ I his Srx6 14.4 4430 PARTIC なこと %

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Ray distribution over half xy image plane (y>/0) for  $\alpha=2$  arc-minutes,  $F_m=2m$ , M=8x,  $L_H^{\rm i}=3.3$  cm,  $L_{\rm E}=3.7$  cm. Also, the image plane grid is  $\Delta XG=0.1015$  arc-secs and  $\Delta XG=0.29775$  arc-secs. The entrance pupil area for each ray is  $\Delta A=2.50203x10^{-5}$  cm<sup>2</sup>.

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spread functions in Figs.35-37 result from the strong aberrations and the vignetting effects. (For on axis radiation, all ray are incident into a single cell, as designed.)

Tables 5-7 and Figs.32-37 contain significant information about the performance of the ERXRT system. The results can be summarized, in part, by Fig.38, which plots different measures of resolution (RMS, FWHM, 50% enclosed energy) versus the field angle. Laboratory experience has suggested that the average of the meridional and sagittal FWHM provides a reasonable measure of resolution for glancing incidence x-ray systems. Table 8 details these results.

TABLE 8

Field angle Arc-minutes	RMS(arc-sec)	Average FWHM(arc-secs)	Scale Factor RMS/Av.FWHM
0.5	0.17197	0.059553	2.8876
1.0	0.86073	0.378115	2.276
2.0	3.4377	1.1615	2.9597

Also, given in Table 8 is a scaling factor which is defined as the ratio of the RMS to the average FWHM value. In

order to transform the RMS data for different microscope mirror lengths into resolution data, it is proposed to divide the RMS data by the scaling factors given in Table 8. This will be considered in more detail in Section E. Before closing the present discussion of the point spread function, it is useful to note the percent of energy contained under the central peak of the line spread functions in Figs. 32-37.

Table 9 gives the transmittance of the ERXRT system under consideration and the percent energy under peaks of line spread function.

TABLE 9

Field Angl (arc-mins)	e Transmi (%)			FWHM (%) Sagittal
0.5	62.	15	10.0	13.4
1.0	35	. 6	5,5	6.5
2.0	16.	<b>. O</b>	2.3	3.7

A practical consideration in determining the resolution over the field of view for the ERXRT system is the threshold power for operation of the CCD detectors. This point should be analyzed more carefully than was possible with CCD data available for this study.

## E. Optimization of the Microscope

The microscope variables available for optimization are the focal length,  $F_m$ , the magnification, and the mirror lengths  $L_H$ ' and  $L_E$ . As a result, the overall length consideration, the MSFC ERXRT design teams have selected  $F_m$  = 2m for the fabrication effort. In terms of the magnification, the plate factor (PF) for the ERXRT is

$$PF = \frac{180 \quad 3600 \text{ arc-secs } 1}{190.5 \text{cm}}$$

$$= \frac{1082.754888 \text{ arc-secs}}{\text{M}}$$
(32a)

By matching the limit of resolution of the S056 telescope (0.8 arc-secs) to two adjacent 30 micron pixels on the image plane, the desired plate factor for the ERXRT system is

$$PF = \frac{0.8 \text{ arc-secs}}{0.0060 \text{cm}} = 133 \frac{1}{3} \frac{\text{arc-secs}}{\text{cm}}.$$
 (32b)

Equating Eqs.32a-b and solving for M gives

$$M = 8.12.$$
 (32c)

Taking these calculations into consideration the MSFC ERXRT design team has selected for the fabrication M = 8x, which

has the plate factor

$$PF = 135.3443610 \frac{\text{arc-secs}}{\text{cm}}$$
 (33)

Using the plate factor given by Eq.33, the half field of view for the 320X 512-30 micron CCD array is

1/2 field of view = 65 x 104 arc-secs

$$1/2$$
 diagonal view =  $122$  arc-secs. (34)

In view of Eq. 34, a practical half field of view of ERXRT will be considered to be 1.75 arc-minutes. It now remains to optimize the mirror lengths of the ERXRT.

As established in Sections B-D, the RMS and transmittance increase with increasing  $L_{H}$ ,  $L_{E}$ . However, it is desirable to select  $L_{H}$ ,  $L_{E}$  for maximum transmittance. Then select the fabrication constant K such that the resolution at 1.75 arc-min field angle corresponds to the limit of resolution of the S056 telescope. Figure 39 gives the RMS versus K at  $\alpha = 1.75$  arc-min for  $L_{H}$ ,  $L_{E}$  which give the maximum transmittance. Using the scaling factor 2.9597 from Table 8, it follows that an RMS = 2.37 arc-secs at full field will translate to sub-arc second resolution. Thus, K = 2.02 is optimum. Figure 40 displays  $(L_{H})/(L_{E})$  versus K for maximum transmittance at  $\alpha = 1.75$ 

arc-minutes, which indicates  $(L_H'/L_E) = 1.055$  for K = 2, or

 $L_{H}' = 2.9160 \text{ cm}$ 

$$L_2 = 2.7640 \text{ cm}.$$
 (35)

In view of the resolution improvements resulting from defocusing the image plane, discussed in Section B, which were not considered in Table 8, and from laboratory experience with the S056 optics, one may expect the potential resolution to be a little better than 0.8 arc-secs for the microscope defined by Eq.35, which suggest building the microscope with maximum K (=2.5) for maximum transmittance

$$L_{H}^{*} = 3.82 \text{ cm}$$
 (K=2.5)

$$L_E = 3.2951 \text{ cm}.$$
 (36)

The RMS and transmittance for the microscope defined by Eqs.36 is given in Table 10.

TABLE 10

	(arc-min)	RMS (arc-secs)	 Transmittance(%)
_	0.5	.17197	62.15
	0.75	.46634	57.90
	1.0	.54292	45.70
	1.25	1.51317	31.89
	1.50	2.2303	25.70
	1.75	3.0472	21.59
	2.0	3.9754	18.6

Using the scaling factor from Table 9 and defocusing the image plane by approximately 4mm (see Fig.20) gives resolution for the ERXRT system of approximately 0.8 arc-sec.

#### F. Aperture Stops

The purpose of aperture stops or baffles is toblock unwanted radiation from striking the image plane CCD detector array. There are two types of unwanted radiation leaving the S056 telescope which require different types of baffles. First, for large field angles, there are some highly distorted rays leaving the S056 telescope which will strike the entrance plane of the microscope at radii greater than the radius of H',  $R_{\rm H}$ '(min), at  $Z_{\rm H}$ '(max) (=172.0978cm). These exterior, unwanted rays will miss the microscope altogether and can be blocked from striking the image plane by use of a large exterior baffle mounted in front of the microscope at  $Z_{\rm H}$ '(max), with a hole of diameter  $2R_{\rm H}$ '(min) ( $R_{\rm H}$ '(min)=1.226955 cm) centered with respect to and perpendicular to the optical axis.

The second type of unwanted rays pass into the interior of the microscope thru the plane at  $Z_H$ '(max) with radii less than  $R_H$ '(min), but either hit H' and miss E or hit E without reflecting from H'. Figure 41 displays the maximum and minimum aperture radii as a function of the field angle.  $R_{1S}$  refers to radii on the front aperture plane at  $Z_H$ '(max) and  $R_{2S}$ , the back aperture plane at  $Z_E$ (min). For field angles greater than 0.5 arc-mins

 $R_{LS}$  (max) is greater than  $R_H$ '(min) resulting in exterior unwanted rays. These rays can not be used for the present microscope imaging and must be blocked from striking the image plane. It is interesting to note from Eq.6 that as  $F_m/M$  increase, the microscope intersection diameter increases which is one way to increase  $R_H$ '(min), and thus, to minimize the exterior unwanted rays. Also, from Fig.41,  $R_{2S}$  (max) is greater than  $R_E$  (min) (=1.4353703 cm) at  $Z_E$  (min) which indicates the presence of interior, unwanted rays for field angles greater than 0.25 arc-mins. Since  $R_{2S}$  (min) is constant as a function of the field angle, it would appear that the second aperture stop does not have a strong influence on rays which strike both H' and E. It is also interesting to note that for  $\alpha$ =0 the value  $R_{S1}$  (min) = 1.7784 from Fig.41 is consistent with the following:

 $R_{S1} = (F_w - Z_H^*(max)) \tan 4\theta m$ 

 $= (190.5-172.0978) \tan(4*.916^{\circ}) \text{ cm}$ 

= 1.1784 cm

where the fact that the microscope intersection rays are adjacent to front aperture stop for an axis incident light and make an angle of 40m with the Z axis have been used.

The data presented in Fig.41 was based on the ray intercepts with the aperture planes of both the wanted and

unwanted rays. Table 11 presents the minimum values of  $R_{S1}$  and  $R_{S2}$  for the wanted rays, ie, rays which intercept H' for  $R_{S1}$  and both H' and E for  $R_{S2}$ .

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TABLE 11

α (arc-min)	R <sub>S1</sub> ,min (cm)	Rs2,min (cm)	•
0	1.1784	1.3967	
• 5	1.1755	1.3967	
.75	1.1758	1.3975	
1.0	1.1757	1.3975	
1.5	1.1762	1.3975	
2.0	1.1762	1.3975	

In order to select rad?, for the aperture stops to be used in the ERXRT system, both RMS and transmittance calculations have been done for field angles 0, .5, 1, 1.5, 1.75, 2 arc-mins and for  $R_{\rm S1}$  = 1.16, 1.17, 1.175, 1.1764, 1.1779, 1.18 cm and  $R_{\rm S2}$  = 1.35, 1.36, ..., 1.40 cm. The results were independent of  $R_{\rm S2}$  in the range of 1.35 to 1.39 cm. When  $R_{\rm S2}$  = 1.40 cm, the microscope intersection rays are blocked, resulting in large RMS values. Therefore,

 $R_{S2} = 1.35$  to 1.3975 cm

is the recommended value for radius of the back aperture stop. Table 12 presents the RMS, transmittance, and number of unwanted rays for  $R_{\rm S2}=1.39$  cm. It follows from the

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TABLE 12:  $R_{S2} = 1.39$  cm

R <sub>S1</sub> (cm)	α(arc-mins)	RMS (arc-secs)	TF F	ANSMITTANC ∦Wanted	E #UN ALL	WANTED RAYS
1.16	0 0.5 1.0 1.5 1.75 2.0	0 .1719 .9499 2.230 3.050 3.975	100 62. 45. 25. 21.	.7 1757 .7 988 .6 830	0 959 755 1331 1433 1505	0 959 393 238 179 170
1.17	0 .5 1.0 1.5 1.75 2.0	0 .1719 .9499 2.230 3.050 3.975	100 62 45 25 21 18	.7 1757 .7 988 .6 830	0 310 540 1195 1330 1403	0 310 178 102 76 68
1.175	0 .5 1.0 1.5 1.75 2.0	0 .1719 .9499 2.230 3.050 3.975	100 62 45 25 21 18	.7 1757 .7 988 .6 830	0 74 438 1121 1270 1347	0 74 76 28 16
1.1764	0 .5 1.0 1.5 1.75 2.0	0 .172 .9504 2.232 3.05 3.98	100 61 45 25 21	.6 1753 .7 986 .4 823	0 18 410 1107 1258 1337	0 18 48 14 4 2
1.17797	0 .5 1.0 1.5 1.75 2.0	0 .1724 .9521 2.242 3.063 3.991	100 60 45 25 21 18	.2 1239 .4 976 .3 820	0 0 400 1103 1256 1335	0 0 38 10 2 0

TABLE 12 - Continued

R <sub>S1</sub> (cm)	α(arc-mins)	RMS (arc-secs)	TRANSMITIANCE % #Wanted	#UNWANTED RAYS ALL INTERIOR		
1.18	0	O	91.4 3512	0	0	
	• 5	.1733	58.0 2229	0	0	
	1.0	.9593	43.7 1679	400	38	
	1.5	2.283	24.3 934	1103	10	
	1.75	3.121	20.4 786	1256	2	
	2.0	4.075	17.6 678	1335	0	
1.19	0	0	37.7 1448	0	0	
	• 5	.1718	47.5 1827	0	0	
	1.0	.9772	38.6 1485	0	0	
	1.5	2.244	20.9 802	1103	10	
	1.75	3.343	17.3 666	1256	2	
	2.0	4.379	14.9 574	1335	Ö	

data in Table 12 that the RMS and transmittance are not affected by increasing  $R_{\rm S1}=1.16$ , 1.17, 1.175, 1.1764, 1.17797 cm, but there are large reductions in the number of unwanted interior rays. However, when  $R_{\rm S1}$  is further increased to 1.18 or 1.19 cm, there are increases in RMS, resulting from blockage of good imaging rays near the microscope intersection point, and there is some reduction in the number of unwanted, interior rays. From this data,

1.175  $cm \le R_{S1} \le 1.17797$  cm

is the recommended radius of the front aperture stop. It should be noted that for the aperature stops defined by Eqs.38a-b there are some unwanted, interior rays which pass thru the same aperture space as good imaging rays, and thus, can not be blocked from striking the image plane.

#### IV. RECOMMENDATIONS AND CONCLUSIONS

The mathematical equations and computer programs have been developed for ray tracing a coupled Wolter I telescope (S-056 optics) and a glancing incidence hyperboloid-ellipsoid x-ray microscope. The intrinsic microscope variables (glancing angle  $\theta m'$ , intersection diameter 2x\*, and surface parameters) have been evaluated and analyzed for the microscope focal lengths  $F_m = 1$ , 1.5, 2m and magnifications M = 5, 6, 6.5, 7, 8. The RMS spot radius as a function of the field angles 0, .25, ..., 2.5 arc-mins on a flat image plane have been computed in order to evaluate the effect of magnification variations, varying microscope focal lengths, defocusing the image plane and vignetting effects. The point spread function has also been analyzed for  $F_m = 2m$ , M = 8x, and microscope mirror lengths  $L_{H}$ ' = 3.3 cm and  $L_{E}$  = 3.7 cm. Taking this data into account, the microscope has been optimized to comple the S056 optics to the proposed CCD detector array such that the ERXRT system provides sub-arc seconds resolution over a field of view of  $\pm$  2 arc-mins with a energy transmittance of 20% at 2 arc-minutes off axis and 40% at 1 arc-minute off axis. The recommended microscope to achieve these goals is defined by

 $F_{\rm m} = 2m$ , M = 8x, K = 2.5

 $L_{H}^{*} = 3.82 \text{ cm}, L_{E} = 3.2951 \text{ cm}$ 

where the flat image plane is defocused by 4mm towards the microscope.

Three aperture stops have also been designed to block unwanted radiation from striking the image plane. First, in the plane at the front of the microscope hyperboloid surface  $Z_H$ '(max) = 172.0978 cm, there should be two baffles. One stop should have a large hole of radius  $R_H$ '(min) = 1.22696 cm. The second stop should be a disk of radius  $R_{S1}$  = 1.17797 cm. Both of the stops in the front aperture plane should be centered with respect to the optical axis. The second aperture plane should be at the rear of the microscope ellipsoid surface  $Z_E$ (min) = 164.9827 cm. Within the second aperture plane, a disk of radius  $R_{S2}$  = 1.3975 cm. should be centered with respect to the optical axis. Depending upon microscope fabrication techniques used, it may be necessary to redesign the aperture stops for the manufactured system.

APPENDIX A: X-Ray Microscope System Parameters

The x-ray microscope system parameters will be derived by using the same coordinate system as used in the design of the S056 x-ray telescope. From Fig.A-1, F<sub>1</sub> is the focus of H- and E-mirror, F<sub>2</sub> is the second focus of H-mirror, and F<sub>3</sub> is the second focus of the E-mirror. It is assumed that F<sub>2</sub> is also the focus of the Wolter Type I (S056) x-ray telescope. It also follows F<sub>W</sub> is the focal length of the S056 telescope, and F<sub>m</sub> (= $\overline{F_2F_3}$ ) is the axial focal length of the x-ray microscope. Then the center coordinates of H- and E-mirror, O<sub>H</sub>, O<sub>E</sub>, will be given by (O·Z<sub>O</sub>H), (O·Z<sub>O</sub>E) where

$$Z_{OH} = F_W + C_H$$

$$Z_{oE} = F_w - F_m + C_E$$
.

The equations for x-ray microscope surfaces in S056 coordinate system are for the ellipsoid

$$\frac{\left(Z - Z_{oE}\right)^{2} + X^{2}}{A_{E}^{2}} = 1$$

(A-1)



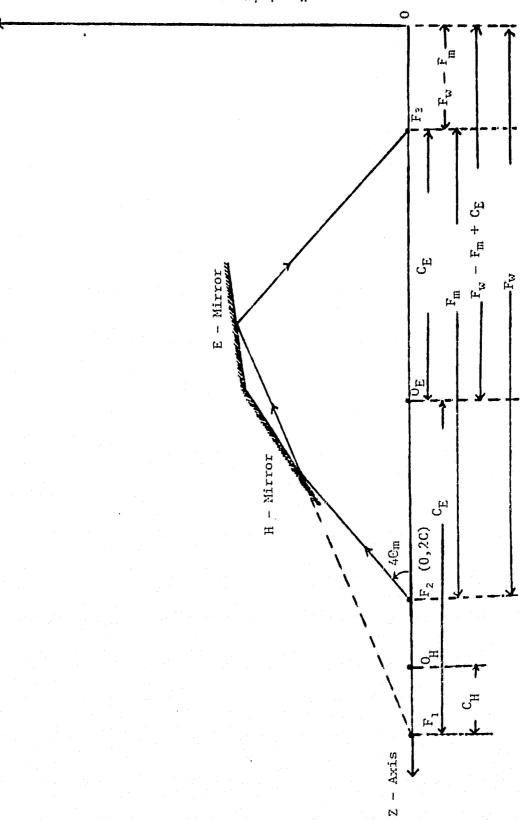


Figure A-1 Cross Sectional Diagram of X-Ray Microscope

where  $B_E^2 = A_E^2 - C_E^2$ , and for the hyperboloid,

$$\left(\frac{Z - Z_{OH}}{A_{H}^{2}} - \frac{X^{2}}{B_{H}^{2}} - 1\right)$$
 (A-2)

where  $B_{H}^{2} = C_{H}^{2} - A_{H}^{2}$ .

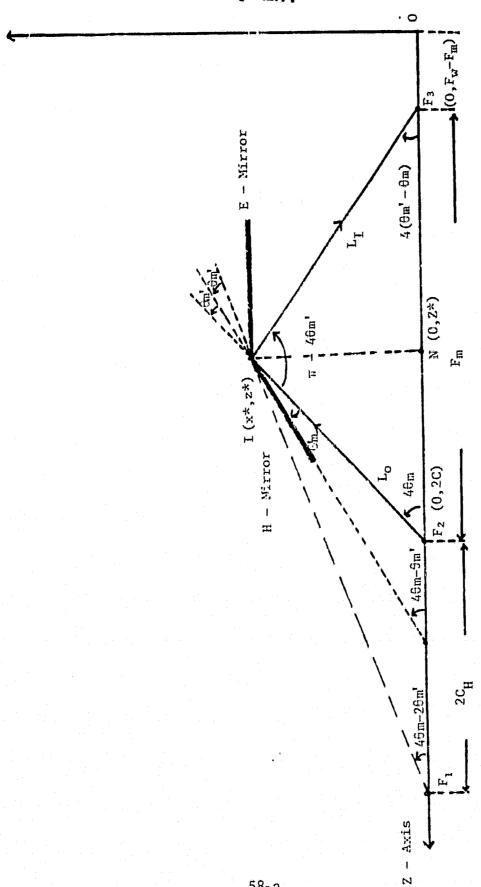
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If  $F_{\text{W}},\ F_{\text{m}}$  are specified, one can solve for  $A_{\text{E}},\ B_{\text{E}},\ A_{\text{H}},$  and  $B_{\text{H}}.$ 

Referring to Fig.A-2, define the magnification of the x-ray microscope (M) as the ratio of the image distance divided by the object distance:

$$M = L_{I}/L_{O} \tag{A-3}$$

where the object is located at  $F_2$  and the image location at  $F_3$ . The object distance is measured from the object to the intersection point of H- and E-mirrors. It is desirable to obtain expression for the microscope parameters in terms of M,  $F_m$ , and  $\theta_m$  (glancing angle at intersection point of telescope). The first step is to solve for  $\theta_m$ ', the glancing incidence angle intersection point of the rays with H-mirror surface. Using the assumption that reflected



Ray Tracing Through The X-Ray Microscope. Figure A-2.

rays from the H-mirror makes  $\theta_m$ ' angle with the E-mirror and the extension of this ray, passes through  $F_1$ , one can derive the following relations:

Considering the  $\Lambda$  F<sub>2</sub>IF<sub>3</sub>, and using the law of sines gives  $\frac{L_{I}}{\sin (40_{m})} = \frac{L_{o}}{\sin 4 (0m' - 0_{m})}$ 

Therefore, from Eq.A-3

$$M = \frac{L_{\rm I}}{L_{\rm o}} = \frac{\sin (4\theta_{\rm m})}{\sin [4(\theta_{\rm m}' - \theta_{\rm m})]}$$

or  $\sin \left[4 \left(\theta_{m}' - \theta_{m}\right)\right] = \sin \left(4\theta_{m}\right)/M$   $\theta_{m}' = \theta_{m} + \frac{1}{4} \sin^{-1} \left[\sin \left(4\theta_{m}\right)\right]$  M(A-4)

Equation A-4 gives  $\theta_m$  as function of M.

Using the law of sines to the  $\Delta$  F<sub>2</sub>IF<sub>3</sub> gives

$$\frac{L_{I}}{\sin (4\theta_{m})} = \frac{F_{m}}{\sin (\pi - 4\theta_{m}')} = \frac{F_{m}}{\sin (4\theta_{m}')}$$

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$$L_{I} = F_{m} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \qquad (A-5)$$

The intersection point coordinates can be written as  $X^* = L_T \quad \sin \left[4(\theta_m' - \theta_m)\right].$ 

Using Eq.A-5, then

$$X* = F_{m} \frac{\sin[4\theta_{m}]}{\sin[4\theta_{m}']} \sin[4(\theta_{m}'-\theta_{m})]$$

Using Eq.A-4 gives

$$X^* = \frac{F_m}{M} \frac{\sin^2(4\theta_m)}{\sin(4\theta_m')}.$$
 (A-6)

Equation A-6 gives X\*, radius at intersection point of the microscope, as a function of magnification M where  $F_m$ ,  $\theta_m$  are fixed.

Using the law of sines for A F2IF3 gives

$$\frac{L_{o}}{\sin[4(\theta_{m}'-\theta_{m}')]} = \frac{F_{m}}{\sin(\pi-4\theta_{m}')} = \frac{F_{m}}{\sin(4\theta_{m}')}$$

Using Eq.A-4

$$L_{o} = \frac{F_{m}}{M} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')}$$
(A-7)

The Z coordinates of the intersection point of H and E mirror can be written as

$$Z^* = F_W - L_0 \cos (4\theta_m)$$

$$= F_W - \frac{F_m}{2M} \frac{\sin(8\theta_m)}{\sin(4\theta_m)}$$
(A-8)

where Eq.A-7 has been used.

From the properties of the ellipsoid, one can write

$$\overline{F_1I} + \overline{I} F_3 = 2A_E \tag{A-9}$$

where  $\overline{\text{IF}_3} = \text{L}_{\text{I}}$ , which is given by Eq.A-5. Since the extension of the reflected ray from the H-mirror passes through F<sub>1</sub>, then the angle<F<sub>2</sub>F<sub>1</sub>I= $4\theta_m$ - $2\theta_m$ '.

Therefore,

$$\frac{X^{*}}{F_{1}I} = \frac{X^{*}}{\sin(4\theta_{m}-2\theta_{m}')} = \frac{L_{o} \sin(4\theta_{m})}{\sin(4\theta_{m}-2\theta_{m}')}. \quad (A-10)$$

Then Eq.A-9 becomes

$$A_{E} = \frac{1}{2} \left[ \frac{L_{o} \sin (4\theta_{m})}{\sin (4\theta_{m}-2\theta_{m}')} + L_{I} \right]$$

Using Eqs.A-4,5,7,

$$A_{E} = \frac{F_{m}}{2} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \left[ \frac{\sin(4\theta_{m})}{M \sin(4\theta_{m}-2\theta_{m}')} + 1 \right]. \quad (A-11)$$

From the properties of an ellipse

$$\overline{F_1F_3} = 2C_E. \tag{A-12}$$

Considering the  $\Delta$  F<sub>1</sub>F<sub>3</sub>I, one can write

$$\frac{2C_{E}}{\sin(2\theta_{m}')} = \frac{L_{I}}{\sin(4\theta_{m}-2\theta_{m}')}$$

or

$$C_{E} = \frac{L_{I}}{2} \quad \frac{\sin (2\theta_{m}')}{\sin (4\theta_{m}-2 m')}.$$

Using Eq.A-5 gives

$$C_{\rm E} = \frac{F_{\rm m}}{2} = \frac{\sin (4\theta_{\rm m}) \sin (2\theta_{\rm m}')}{\sin (4\theta_{\rm m}') \sin (4\theta_{\rm m} - 2\theta_{\rm m}')}$$
 (A-13)

Also,

$$B_E^2 = A_E^2 - C_E^2$$
.

The H-mirror parameters are derived as the following from the properties of the hyperboloid. One can write

$$\overline{F_1F_2} = 2C_H . \qquad (A-14)$$

Using the law of sines for the  $\Delta\,F_1F_2I$  gives

$$\frac{\overline{F_1F_2}}{\sin (2\theta_{m}')} = \frac{L_o}{\sin (4\theta_{m}-2\theta_{m}')}$$

SO

$$C_{H} = \frac{1}{2} I_{0} \frac{\sin(2\theta_{m}')}{\sin(4\theta_{m}-2\theta_{m}')}.$$

Using Eq.A-7 gives

$$C_{H} = \frac{F_{m}}{2M} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \frac{\sin(2\theta_{m}')}{\sin(4\theta_{m}-2\theta_{m}')}.$$
 (A-15)

Using the properties of the hyperbola gives

$$\overline{F_1 I} - \overline{F_2 I} = 2A_H \tag{A-16}$$

where  $\overline{F_2I} = L_0$  and  $\overline{F_1I}$  is given by Eq.A-10.

Then,

$$A_{H} = \frac{F_{m}}{2M} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \left\{ \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}-2\theta_{m}')} - 1 \right\}. \quad (A-17)$$

Also,

$$B_H^2 = C_H^2 - A_H^2$$
.

SUMMARY:

H-mirror Parameters:

$$\frac{(Z-Z_{oH})^{2}}{A_{H}^{2}} - \frac{x^{2}}{B_{H}^{2}} = 1$$

$$Z_{OH} = F_W + C_H$$

$$C_{H} = \frac{F_{m}}{2M} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \frac{\sin(2\theta_{m}')}{\sin(4\theta_{m}-2\theta_{m}')}$$

$$A_{H} = \frac{F_{m}}{2M} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \left[ \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}-2\theta_{m}')} - 1 \right]$$

$$B_H^2 = C_H^2 - A_H^2$$

$$\theta_{m}' = \theta_{m} + \frac{1}{4} \quad \sin^{-1} \left[ \frac{\sin(4\theta_{m})}{M} \right]$$

**z**.,

E-mirror Parameters:

$$\frac{(Z-Z_{oE})^{2}}{A_{E}} + \frac{X^{2}}{B_{E}^{2}} = 1$$

$$Z_{oE} = F_{w} - F_{m} + C_{E}$$

$$C_{E} = \frac{F_{m}}{2} \frac{\sin(4\theta_{m})}{\sin(4\theta_{m}')} \frac{\sin(2\theta_{m}')}{\sin(4\theta_{m}-2\theta_{m}')}$$

$$B_E^2 = A_E^2 - C_E^2$$

Mid-Point Parameters:

$$L_{I} = \frac{F_{m} \sin(4\theta_{m})}{\sin(4\theta_{m}')} ; \quad L_{o} = \frac{F_{m}}{M} \frac{\sin(4\theta_{m}')}{\sin(4\theta_{m}')}$$

$$X^* = \frac{F_m}{M} \frac{\sin^2(4\theta_m)}{\sin(4\theta_m')}$$

$$Z* = F_w - \frac{F_m}{2M} \frac{\sin(8\theta_m)}{\sin(4\theta_m')}$$

#### REFERENCES

- 1. J.D.Mangus, J.H. Underwood, APPLIED OPTICS 8.1, 95 (1969).
- 2. J.W.Forman, Jr., G.W.Hunt, E.K.Lawson, "Analytical Study of The Imaging Characteristics of The Goddard ATM X-Ray Telescope," Technical publication #SP-505-0270, Space Support Division, Sperry Rand Corporation, Huntsville, Alabama, September, 1969.
- 3. H.Wolter, Ann. Phys 10, 94 (1952).
- 4. J.K.Silk, Annals of NY Academy of Sciences 342, 116 (1980).
- 5. OPTICAL DESIGN, MILITARY STANDARDIZATION HANDBOOK, #MIL-HDBK-141, U.S. Government Printing Office, WASHINGTON, D.C., 1962.
- 6. O.N.Stavroudis, "The Optics of Rays, Wavefronts, and Caustics" (Academic Press, New York, 1972).
- 7. R.J.Gagnon, JOSA 58.8 (1968).
- 8. R.C.Chase, J.K.Silk, APPLIED OPTICS 14.9, 2096 (1975).
- 9. M.J.Boyles, H.G.Ahlstrom, Rev. Sci. Instrum. 49.6, 746 (1978).
- 10. A.Franks, et.al., Annals of NY Academy of Sciences 342, 167 (1980).
- 11. J.M.Davis. A.S.Krieger, J.K.Silk, R.C.Chase, Proc. SPIE 184, 96 (1979).
- 12. D.L.Shealy, "Analysis of NOAλ-MSFC GOES X-Ray Telescope," Final Report under contract #H-34373B, Marshall Space Flight Center, Huntsville, Alabama (1979).
- 13. W.Werner, APPLIED OPTICS 16.3, 764 (1977).
- 14. D.G.Burkhard, D.L.Shealy, APPLIED OPTICS 20.5, 897 (1981).
- 15. C.E.Winkler, D.Korsch, NASA Technical Paper #1088 (1977). APPLIED OPTICS 16.9, 2464 (1977).
- 16. H.Wolter, OPTICA ACTA 18.6, 425 (1971).

- 17. R.Giacconi, W.P.Reidy, T.Zehnpfennig, J.C.Lindsay, and W.S.Muney, J.ASTROPHYS 142, 1274 (1965).
- 18. J.H. Underwood, Am. Scientist, 66.4, 476 (1978).
- 19. R.Giacconi, et.al., J.ASTROPHYS 230, 540 (79).
- 20. M.V.Zombeck, C.C.Wyman, M.C.Weisskopf, Opt. Eng. 21.1, 63 (1982).
- 21. M.V.Zombeck, Proc. AIP Topical Conference on Low Energy X-Ray Diagnostics, Monterey, California, June 8-10, 1981.
- 22. R.C.Chase, J.M.Davis, A.S.Krieger, J.H.Underwood, Proc. SPIE 316, 74 (1981).
- 23. J.M.Davis, "STARPROBE: An Interim Report," contract #955928, Jet Propulsion Laboratory, Pasadena, California, July 2, 1981.

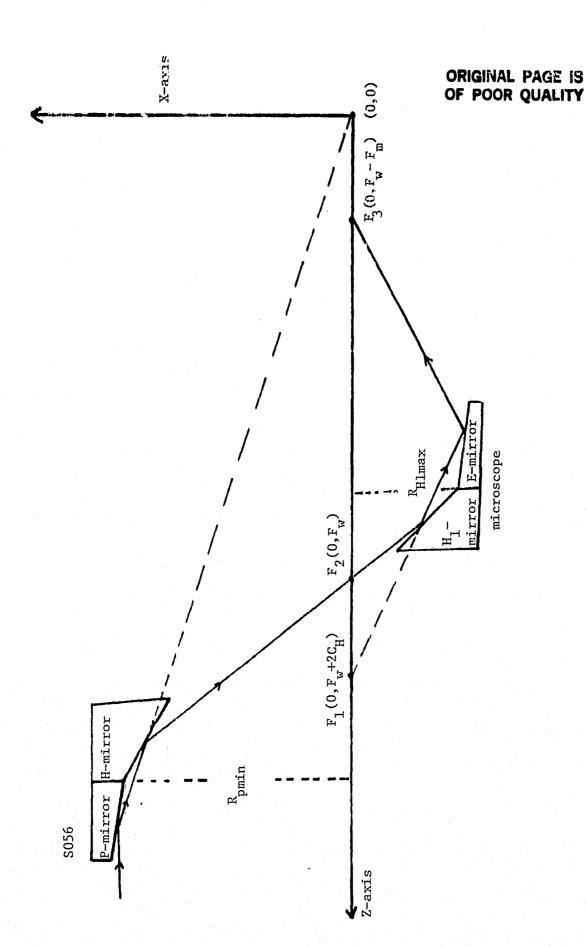


Fig. 1: Symbolic View of the ERXRT System.

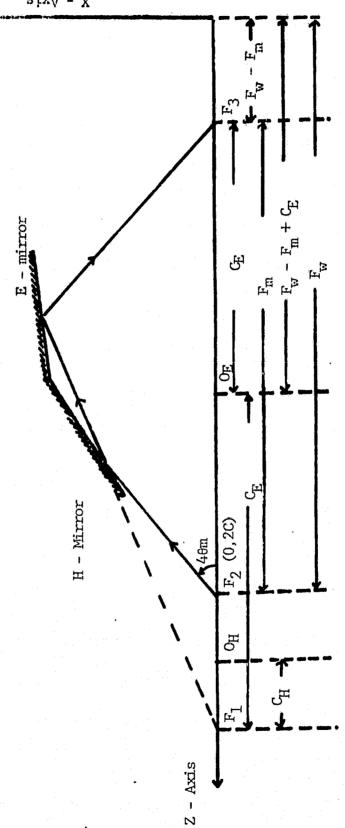
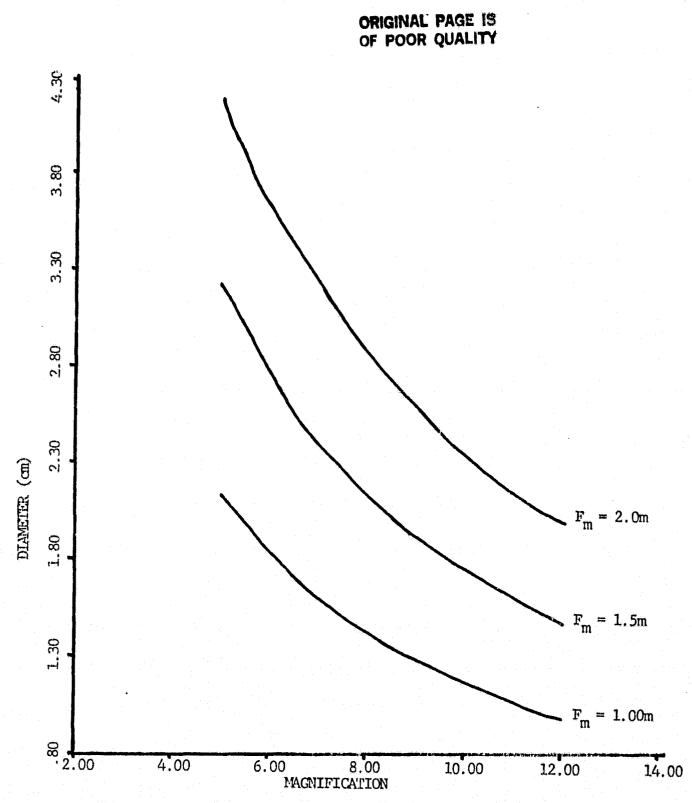


FIGURE 2: Cross Sectional Diagram of X-Ray Microscope

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FIG. 3: Microscope intersection diameter versus the magnification.

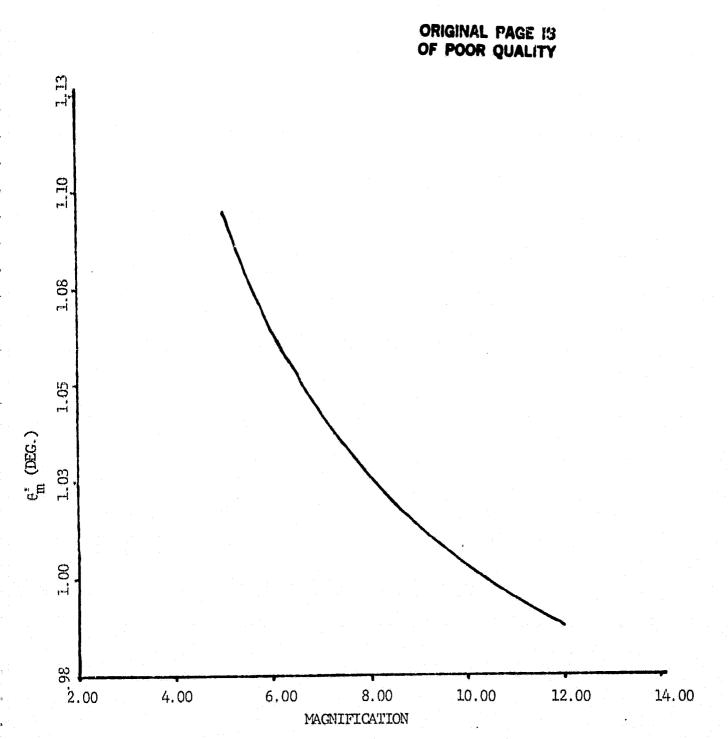


FIG. 4: Glancing angle at the intersection point of microscope versus the magnification for  $\alpha\,=\,0\,.$ 

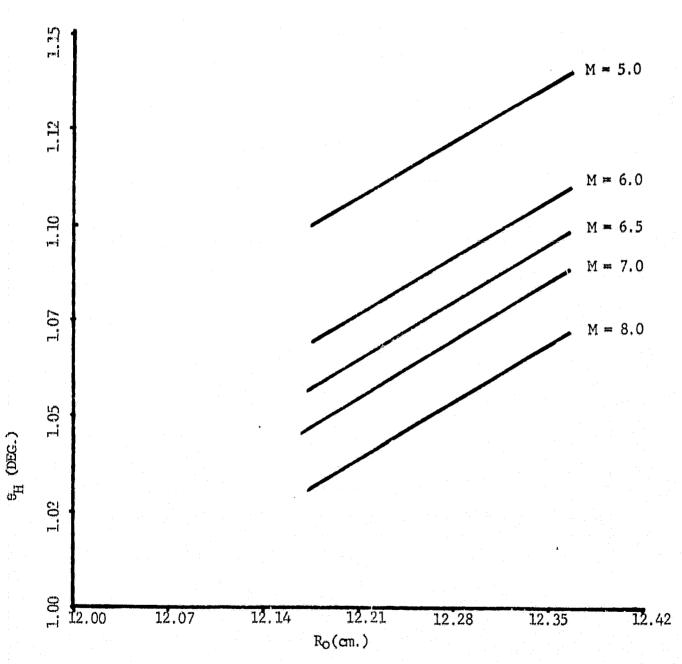
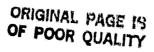


FIG. 5: Glancing angle over the microscope hyperboloid surface versus the entrance pupil radius,  $R_{\rm O}$  for  $\alpha$  = 0.



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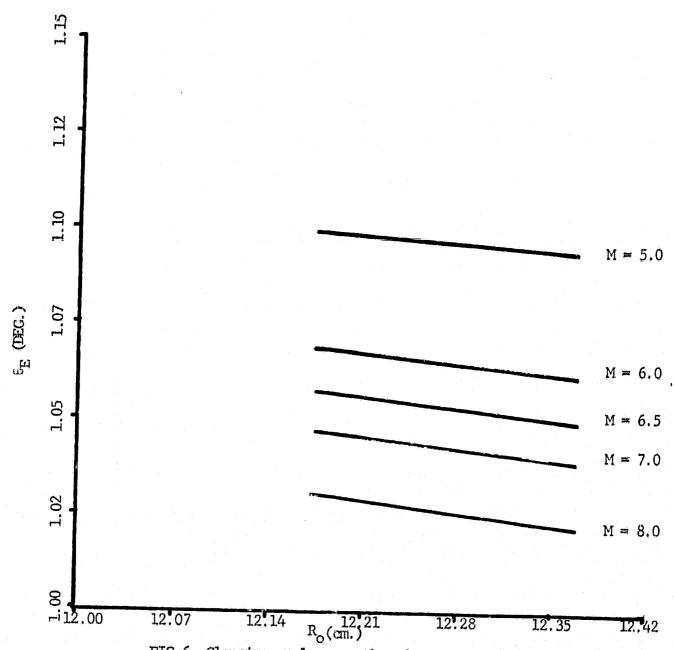
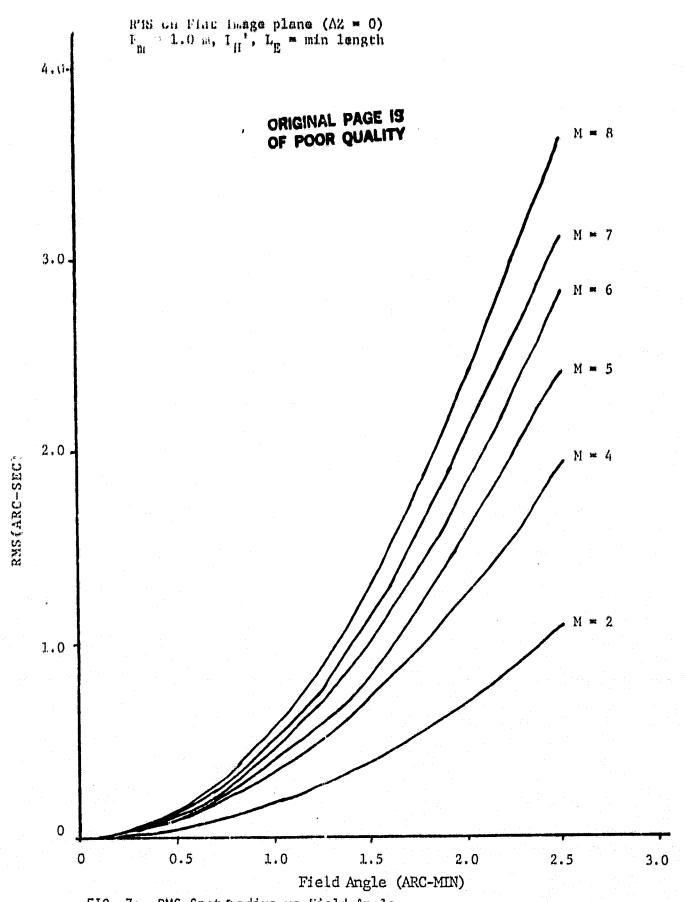


FIG.6: Glancing angle over the microscope ellipsoid surface versus the entrance pupil radius,  $R_0$ , for  $\alpha=0$ .



RM5 ON FLAT IMAGE PLANE ( $\Delta$ Z=0)

\_\_\_

RMS on Image Plane ( $\Delta Z=0$ )  $F_m=2m$ ,  $L_H^{-1}$ ,  $L_E=min$ 

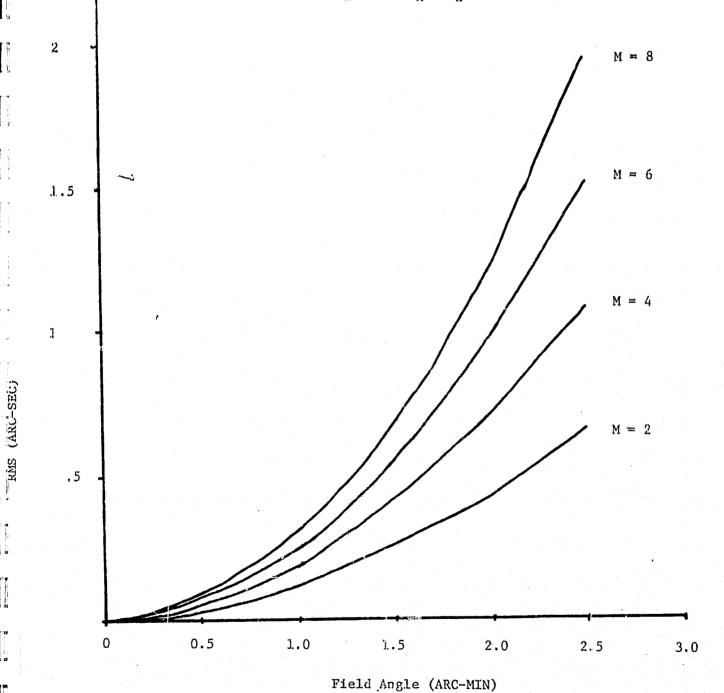


Fig. 9: RMS Spot Radius vs Out Field Angle

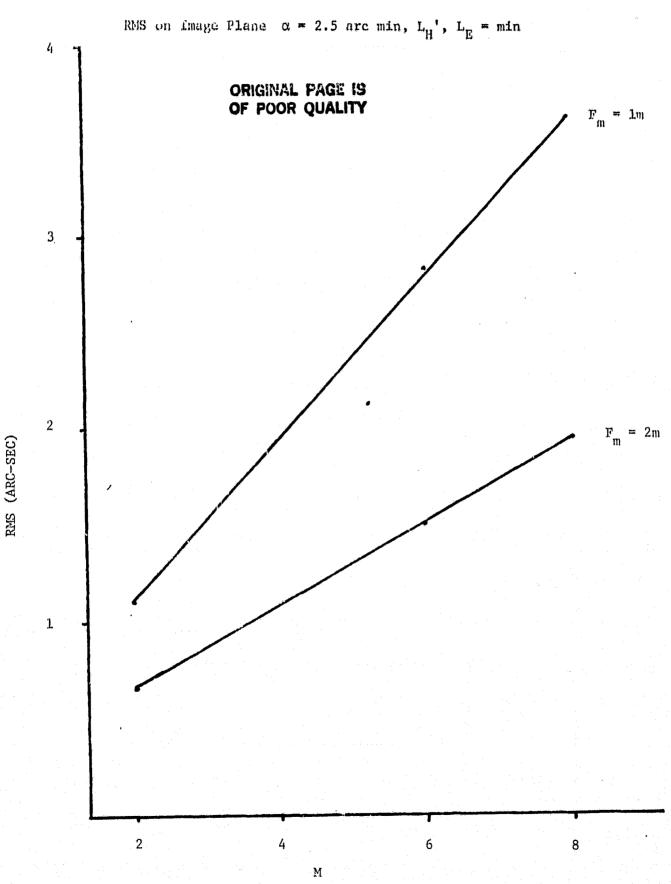
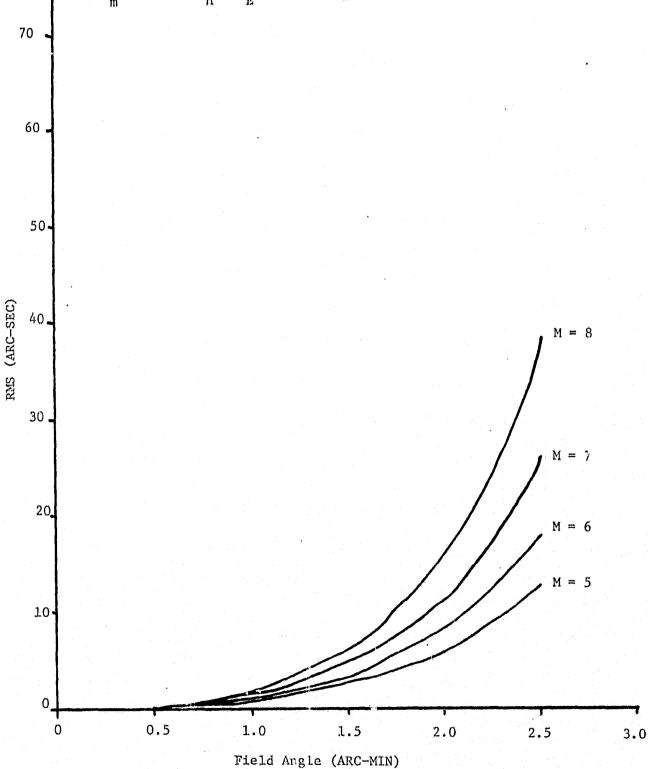


Fig. 10: RMS Spot Radius vs Magnification

RMS on Flat Image Plane ( $\Delta Z = 0$ ) F = 1.5 m, L<sub>H</sub>', L<sub>E</sub> = Max. Lengths



Fig, 11: RMS Spot Radius vs Field Angle

RMS vs. Field-Angles for  $L_{H}^{'}$ ,  $I_{E}^{'}$  - min. & max length  $F_{m}^{'}$  = lm, M = 6x

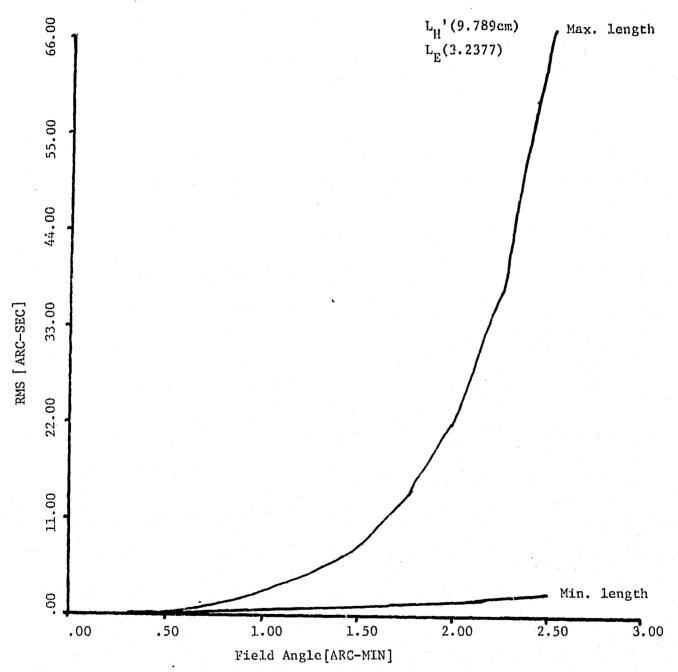


Fig. 12: RMS Spot Radius vs Field Angle

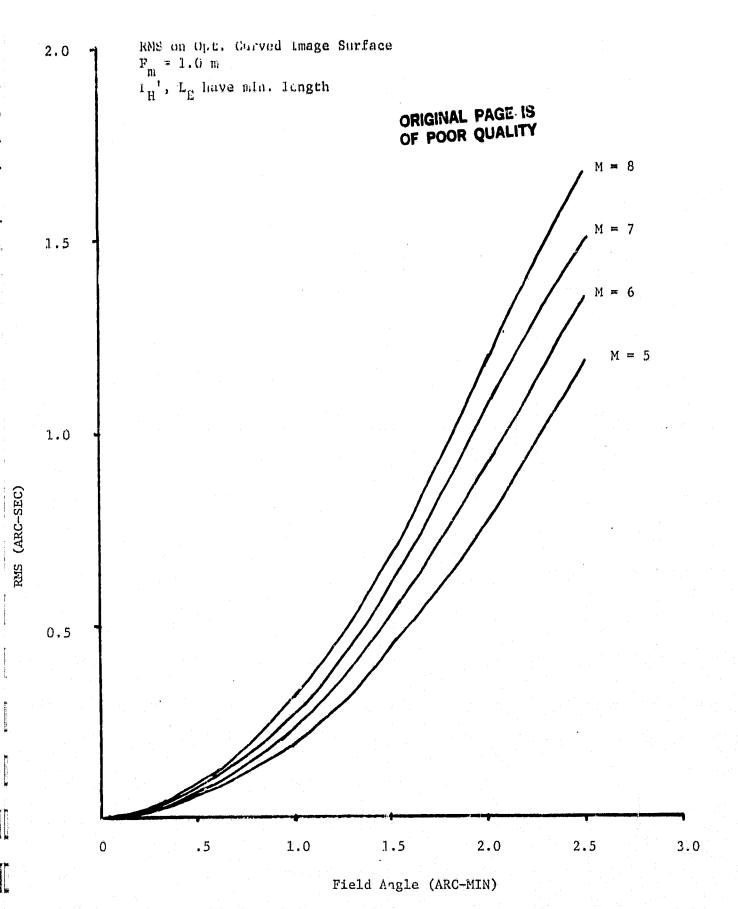


Fig. 13: RMS Spot Radius vs Field Angle

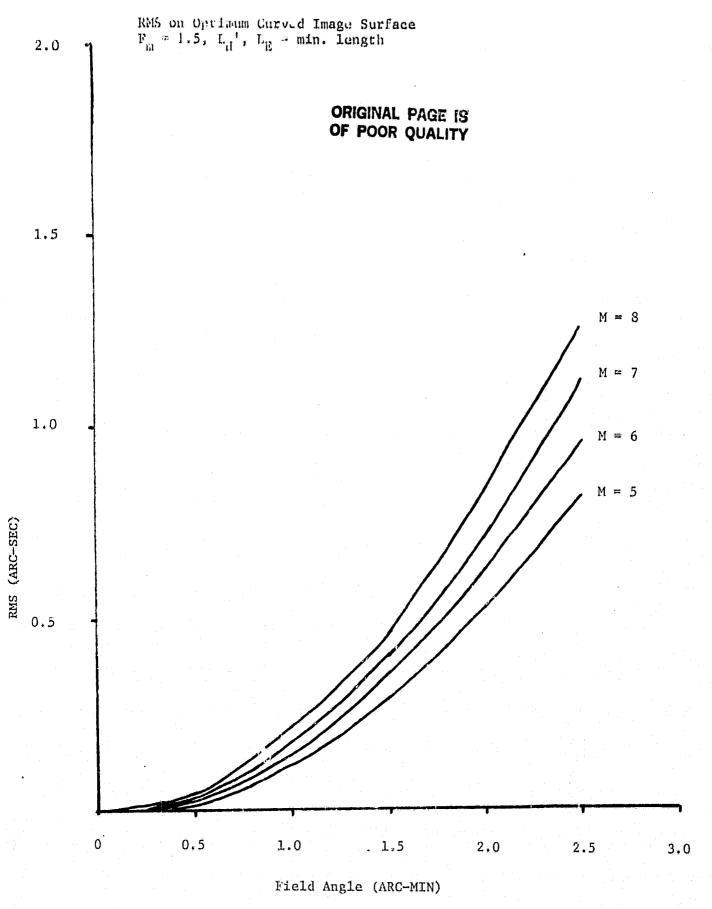
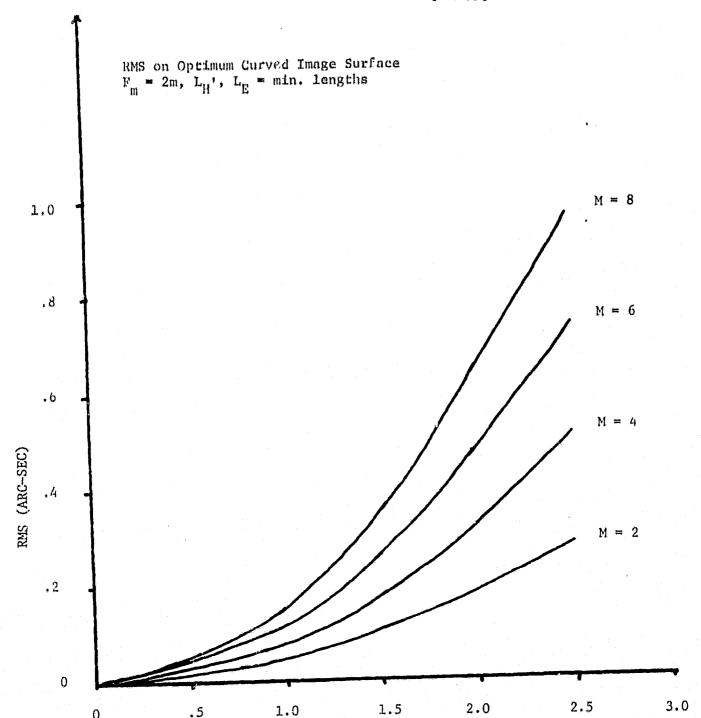


Fig. 14: RMS Spot Radius vs Field Angle



Field Angle (ARC-MIN)

Fig. 15: RMS Spot Radius vs Field Angle

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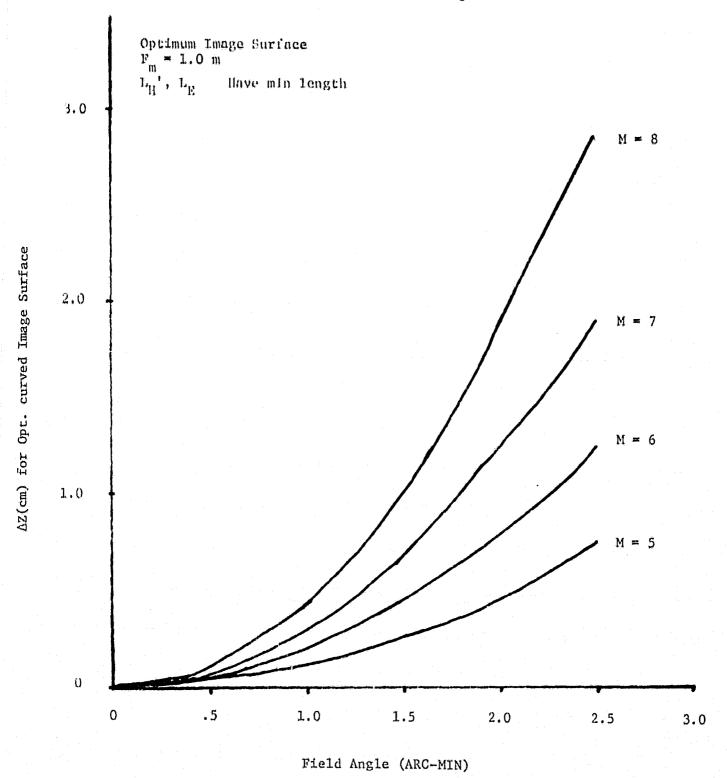


Fig. 16: Optimum Image Surface

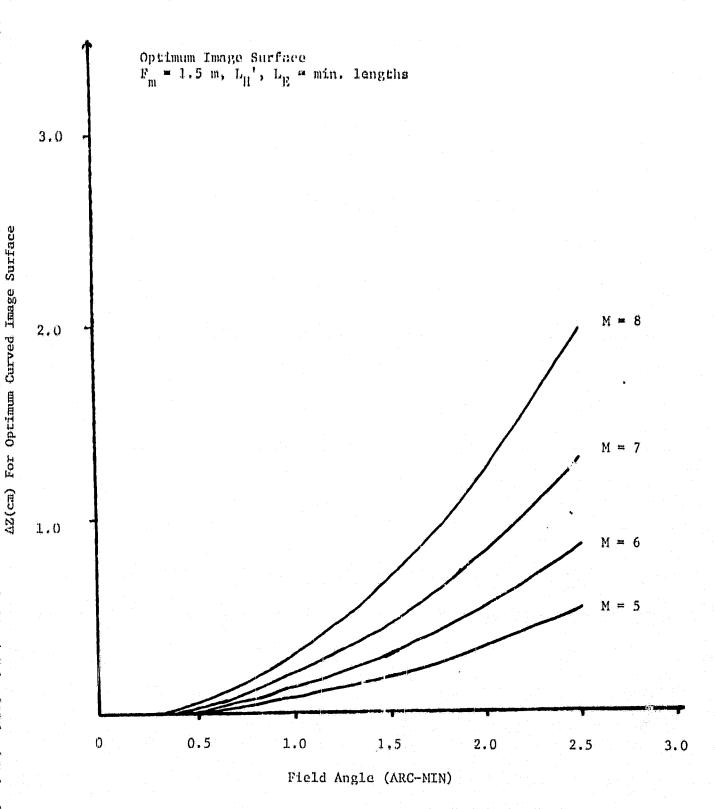
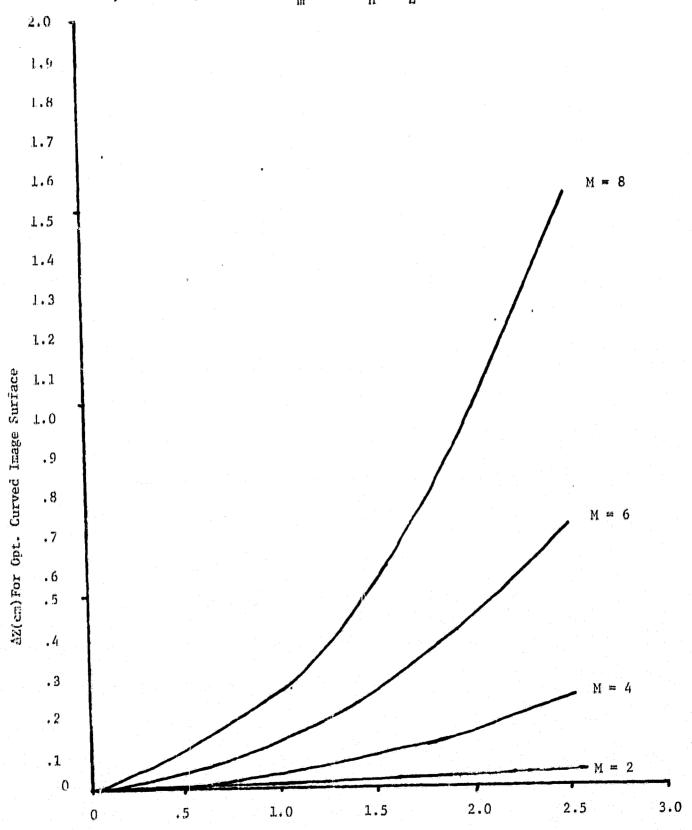


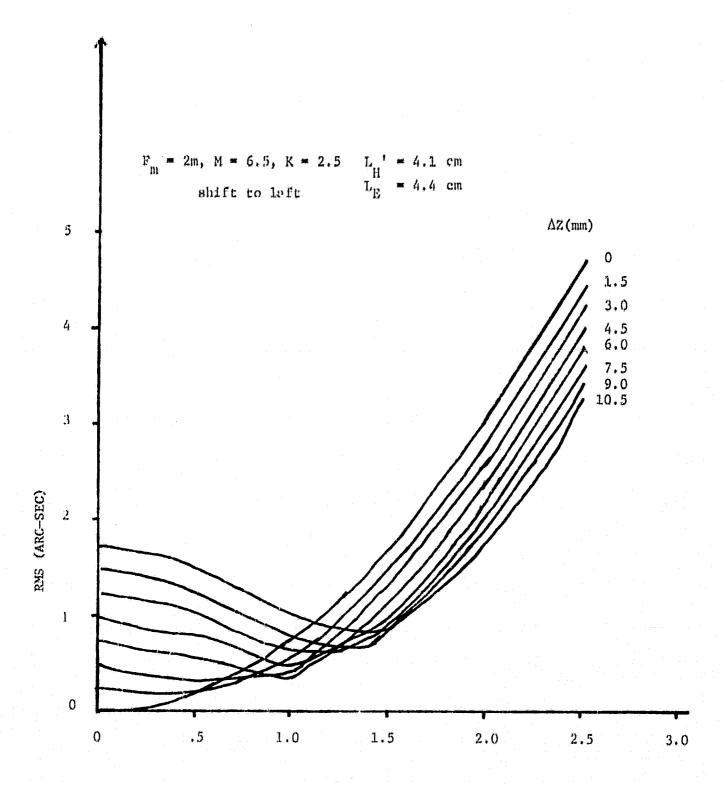
Fig. 17: Optimum Image Surface

Optimize image Surface  $\Gamma_{m}=2m$ ,  $L_{H}$ ,  $L_{E}=min$ . lengths



Field Angle (ARC-MIN)

Fig. 18: Optimum Image Surface



Field Angle (ARC-MIN)

Fig. 19: RMS Spot Radius vs Field Angle

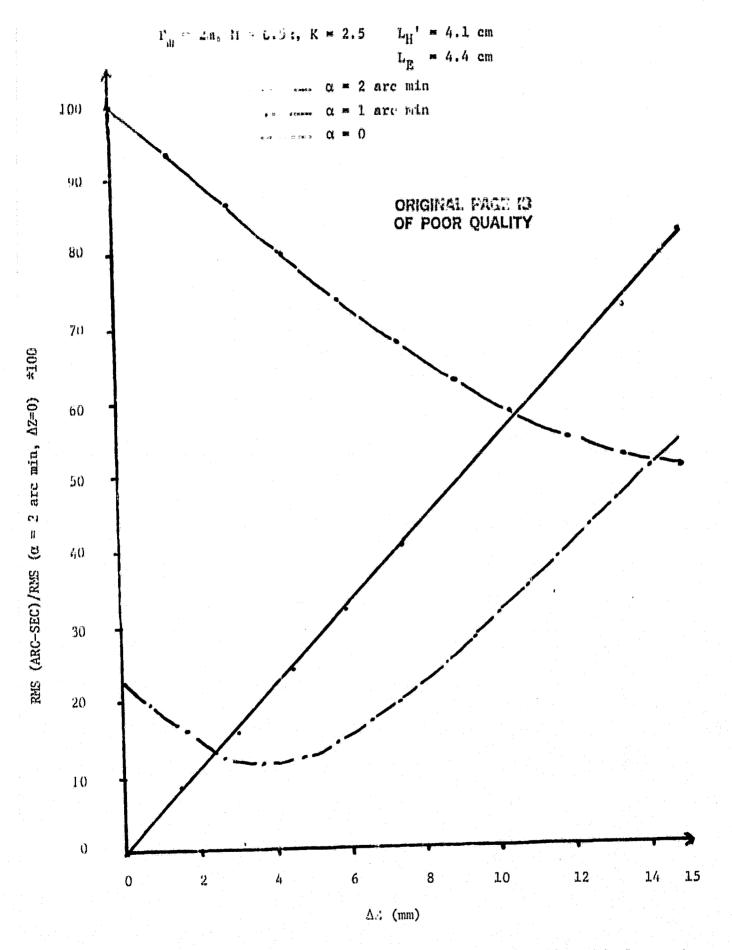


Fig. 20: Normalized RMS Spot Radius vs Image Plane Displacement

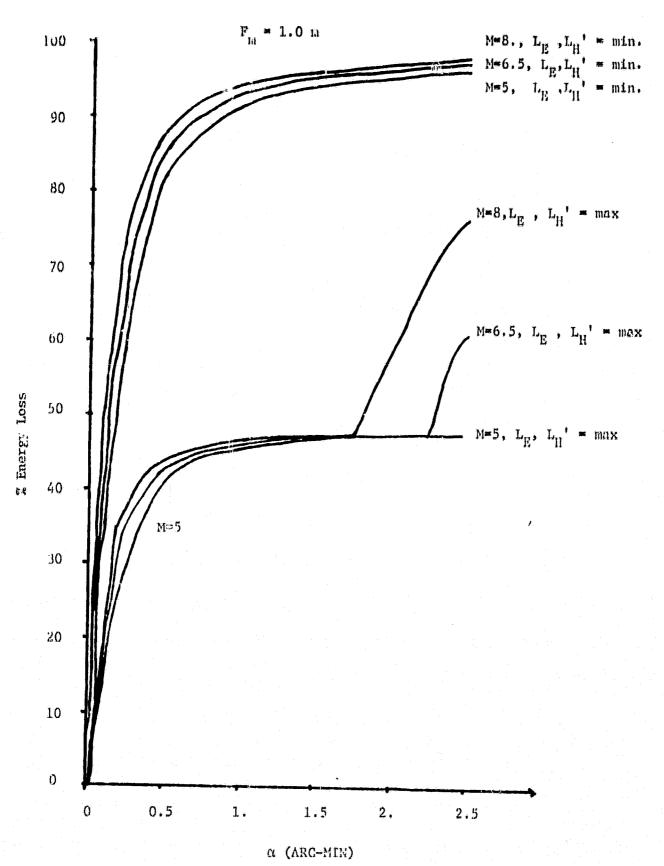


Fig. 21: Percent Fnergy Loss vs Field Angle

% Energy Loss vs H'- mirror's Jength for  $\alpha$  = 1.0 and L<sub>E</sub> is max. F<sub>m</sub> = 1m

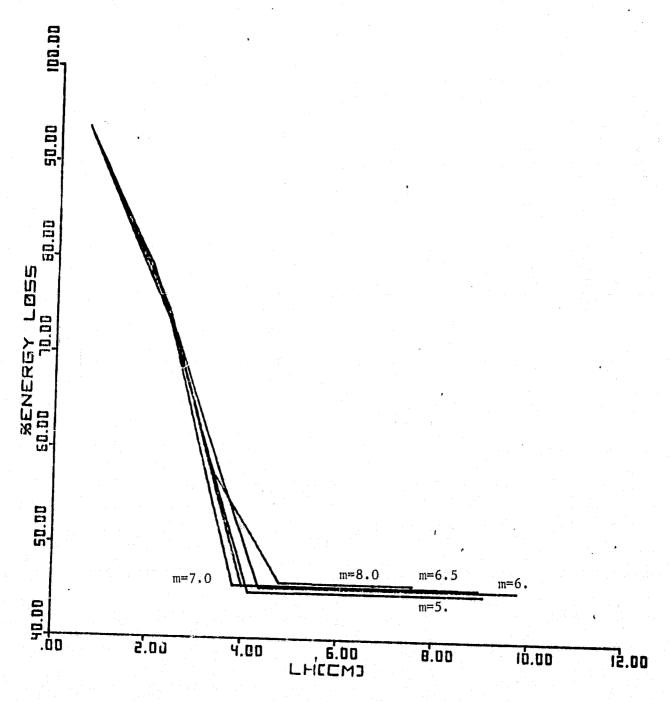


Fig. 22a: Percent Energy Loss vs LH'

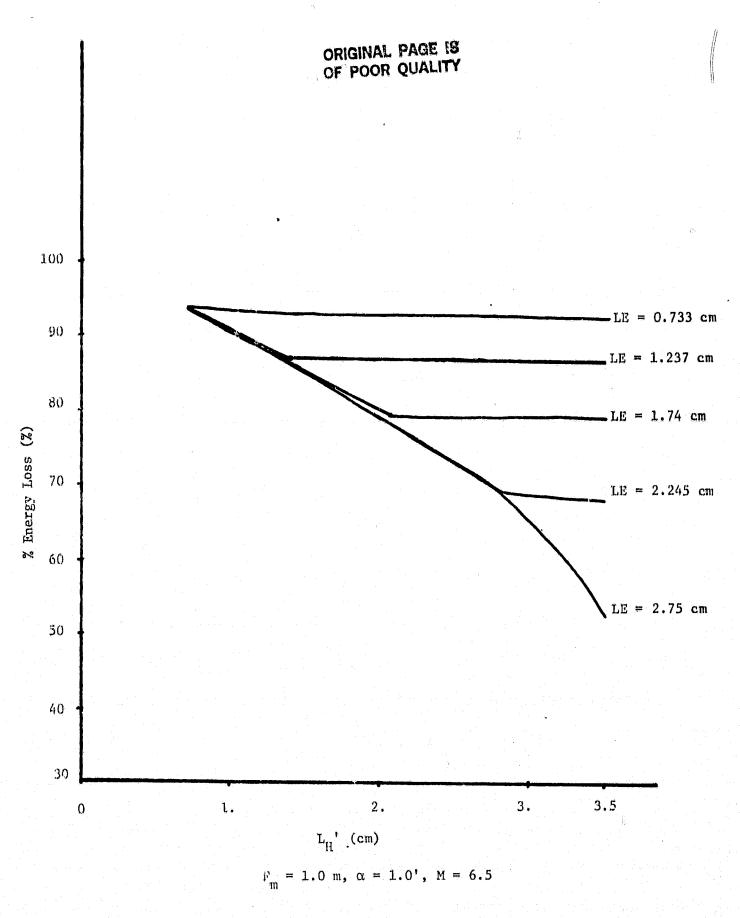


Fig. 22b: Percent Energy Loss vs  $L_{H^{\perp}}$ 

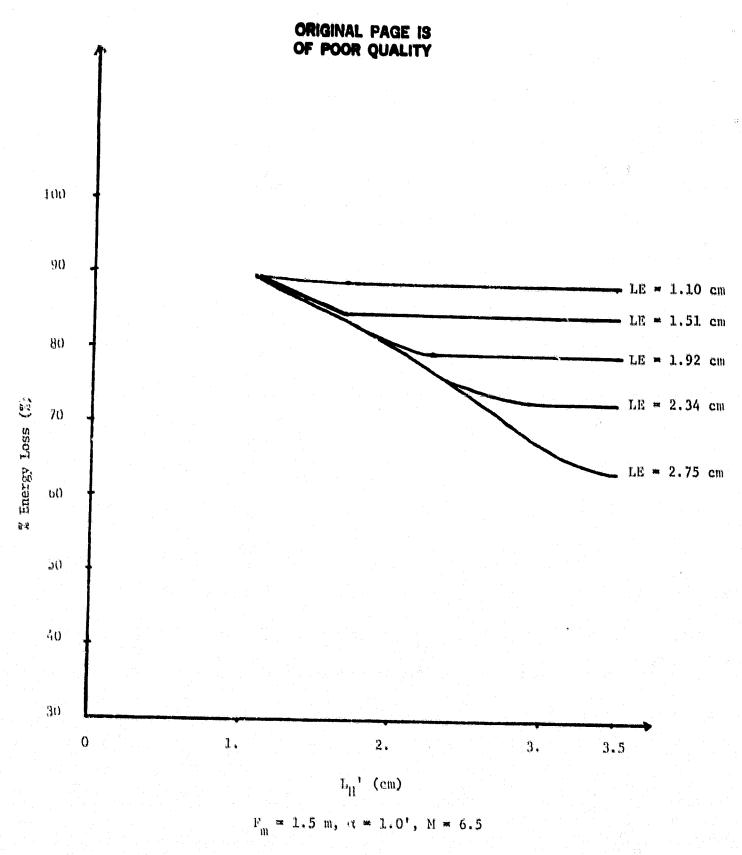


Fig. 22c: Percent Energy Loss vs LH'

% knergy loss vs.  $L_E$  - mirror length for  $\alpha$  = 1.00, and Max. Length of H- mirror and different magnification  $F_m$  = 1m

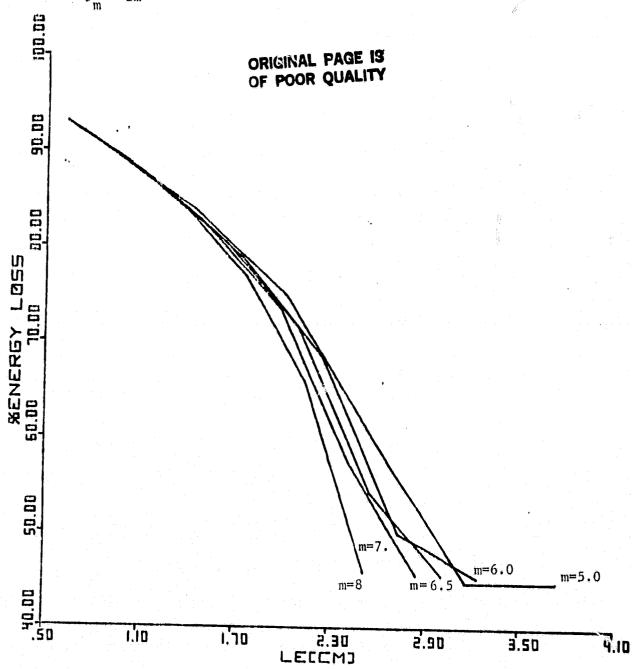


Fig. 23a: Percent Energy Loss vs  $L_{\rm E}$ 

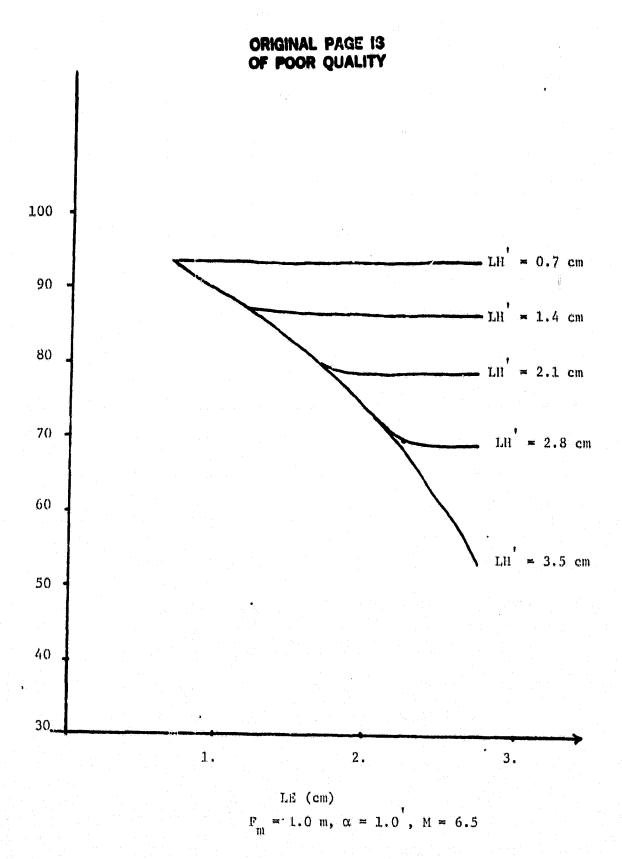


Fig. 23b: Percent Energy Loss vs LE

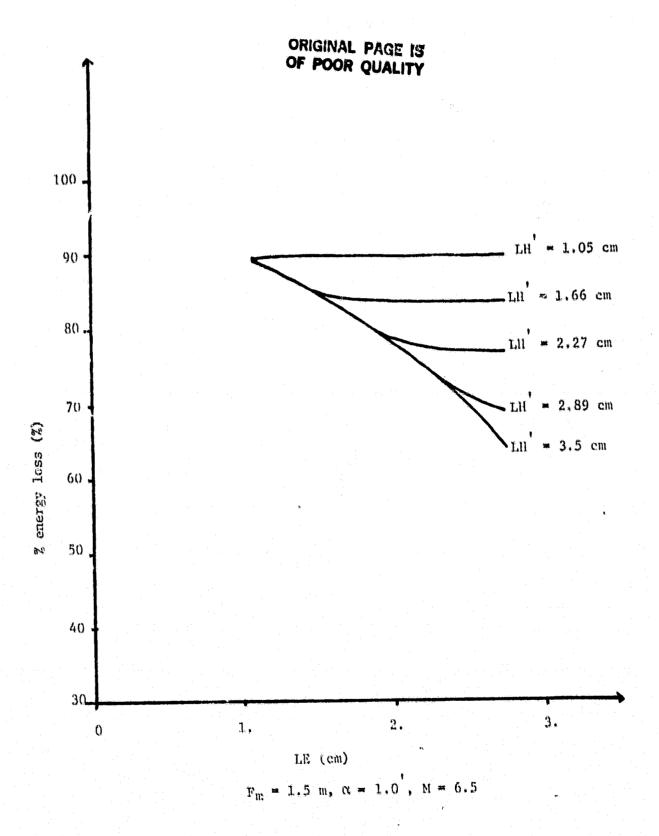


Fig. 23c: Percent Energy Loss vs  $L_{\rm E}$ 

M = 5.0  $L_E$  is max. length  $F_m = 1m$   $\alpha = 1$  are min

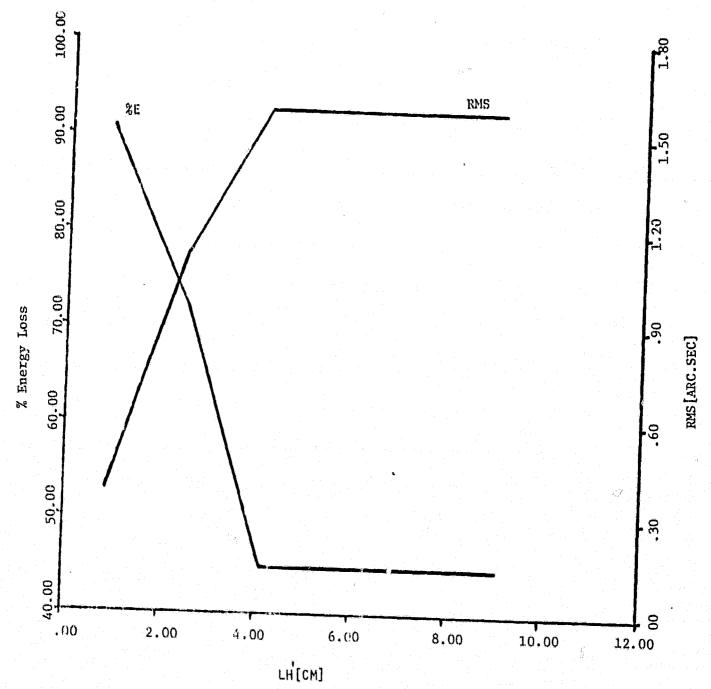


Fig. 24: Percent Energy Loss and RMS Spot Radius vs LH'

M = 5.0  $L_{H}^{'}$  is max.  $F_{m} = 1m$ ,  $\alpha = 1$  arc-min

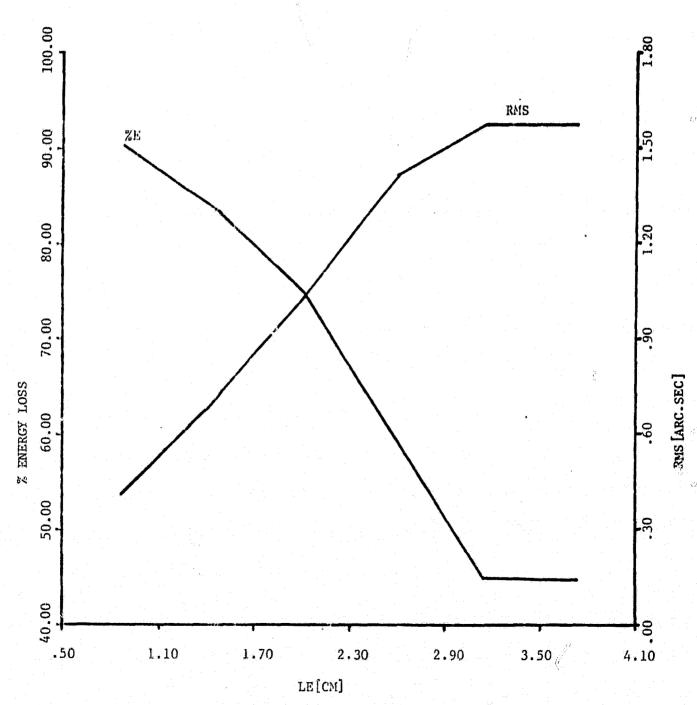


Fig. 25: Percent Energy Loss and RMS Spot Radius vs LE

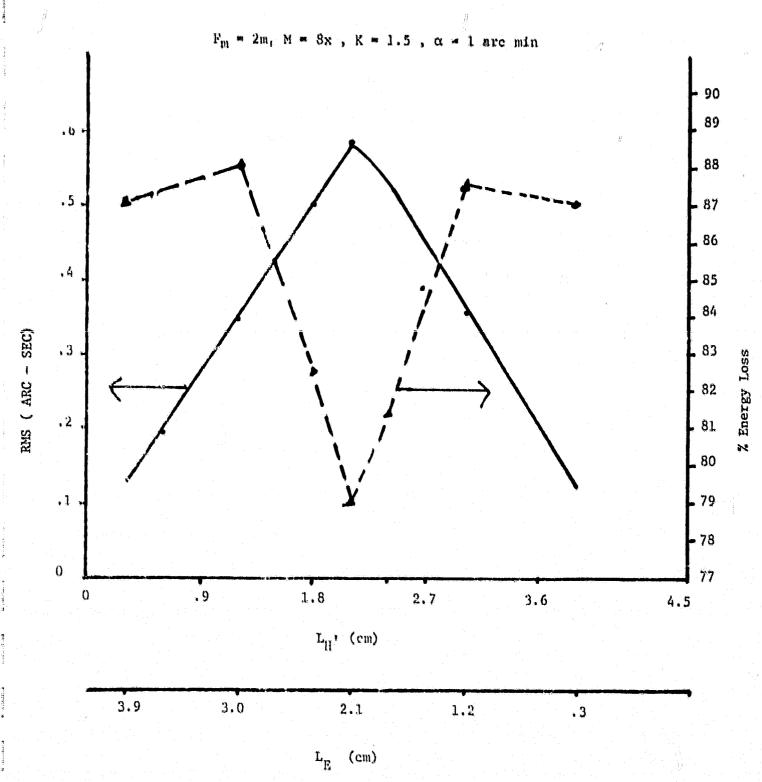


Fig. 26: RMS Spot Radius and Percent Energy Loss vs  $L_{\rm H}$ , and  $L_{\rm E}$ 

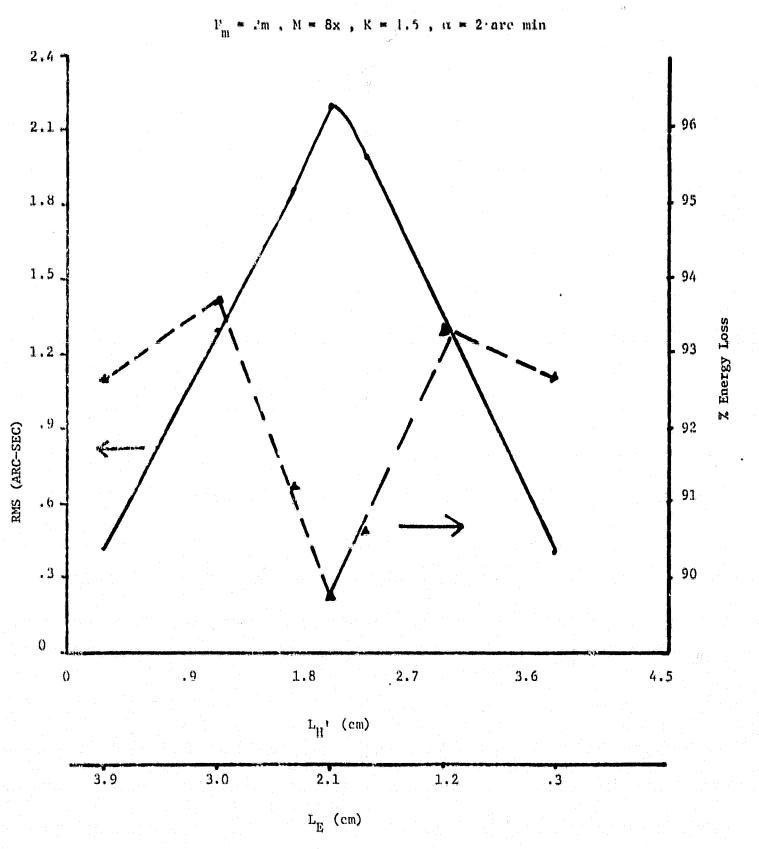


Fig. 27: RMS Spot Radius and Percent Energy Loss vs  $L_{\rm H^{+}}$  and  $L_{\rm E}$ 

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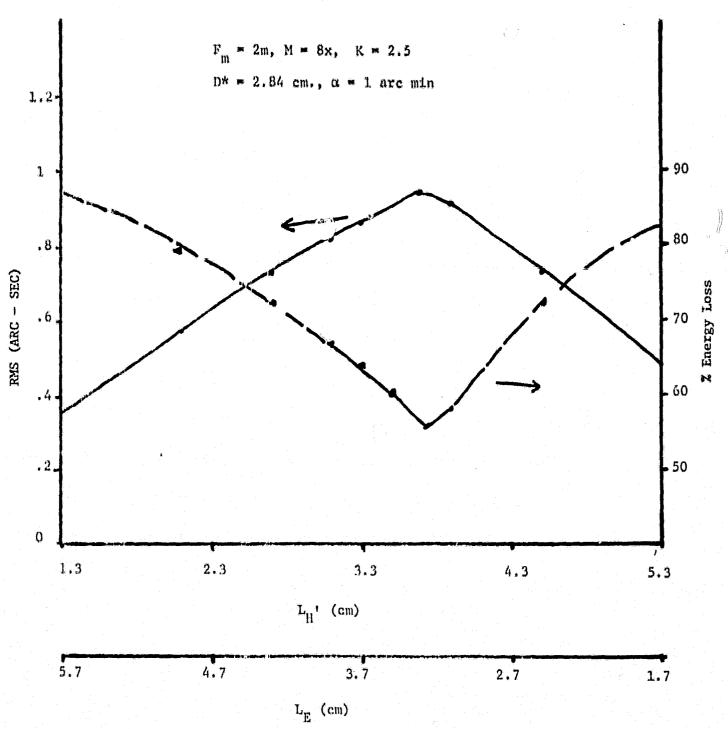


Fig. 28: RMS Spot Radius and Percent Energy Loss vs  $L_{\mbox{H}^{1}}$  and  $L_{\mbox{E}}$ 

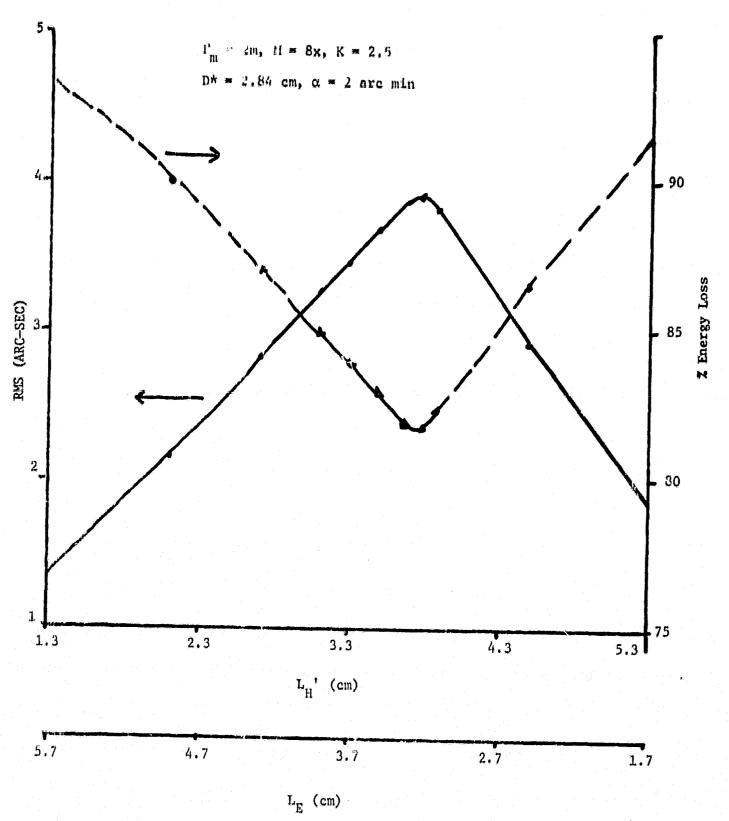
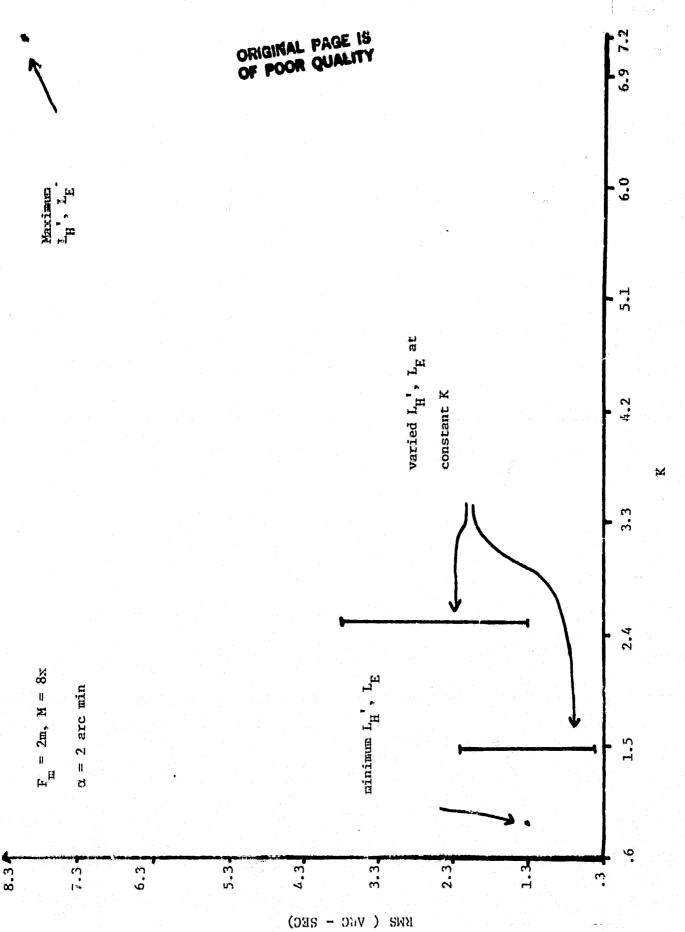
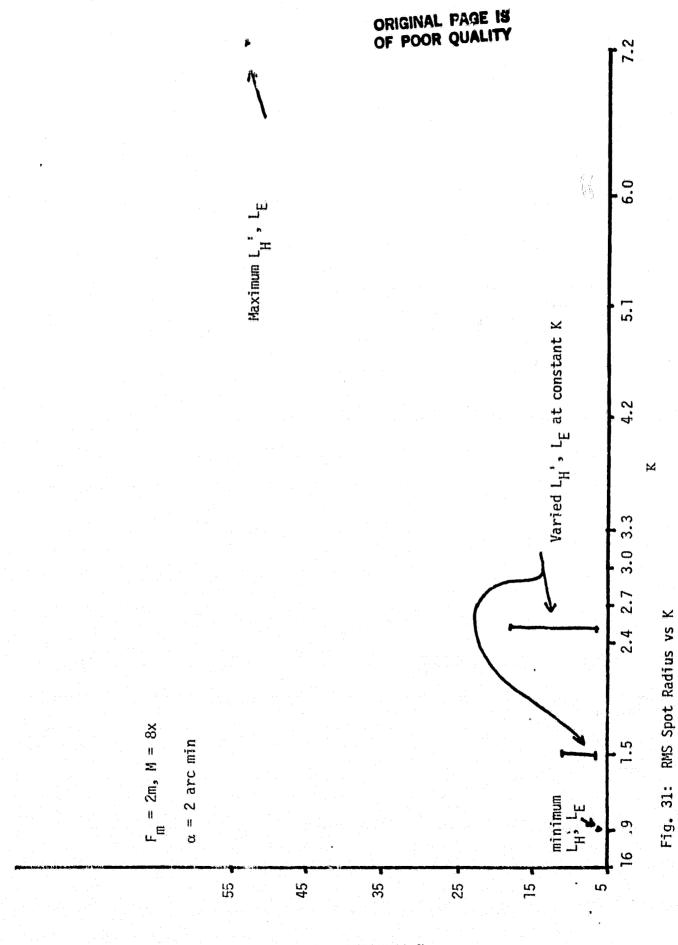


Fig. 29: RMS Spot Radius and Percent Energy Loss vs  $L_{\mbox{H}^{1}}$  and  $L_{\mbox{E}}$ 

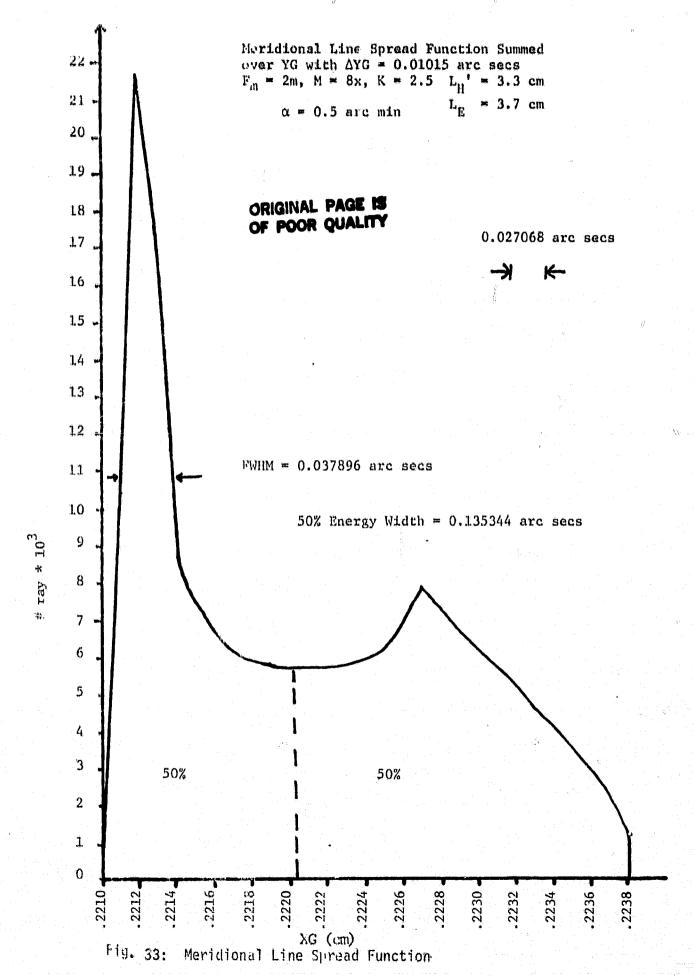


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Fig. 30: RMS Spot Radius vs K



% Leansmittance



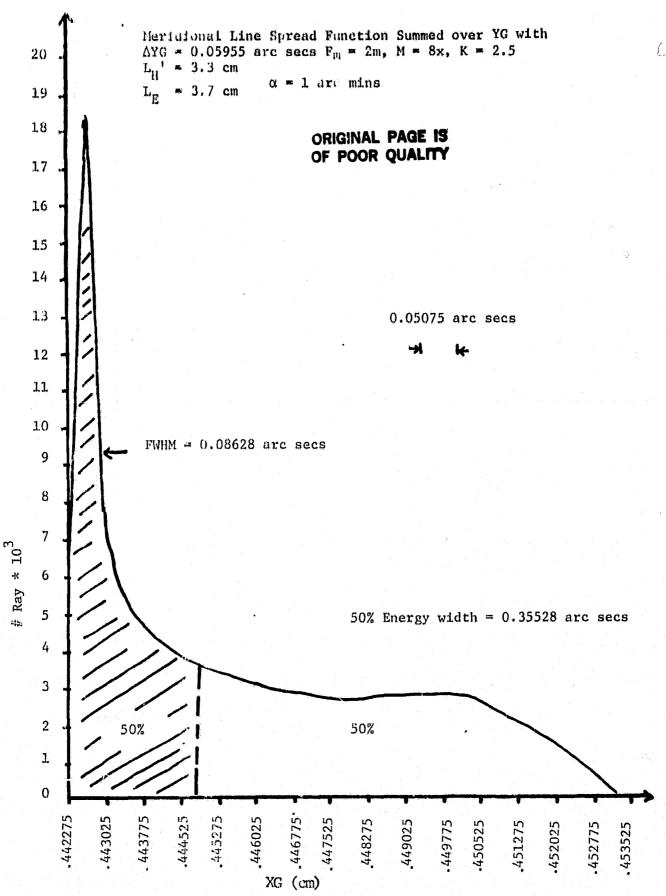


Fig. 33: Meridional Line Spread Function

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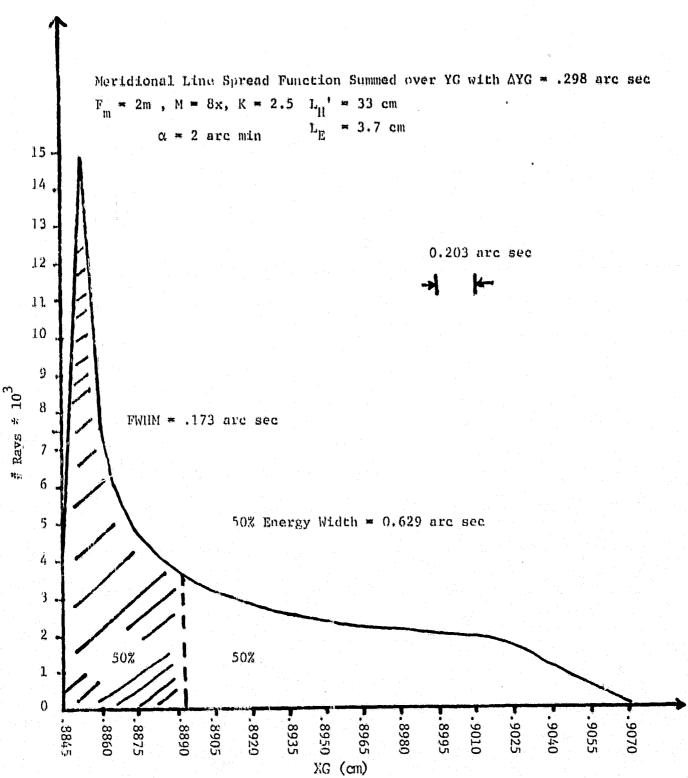
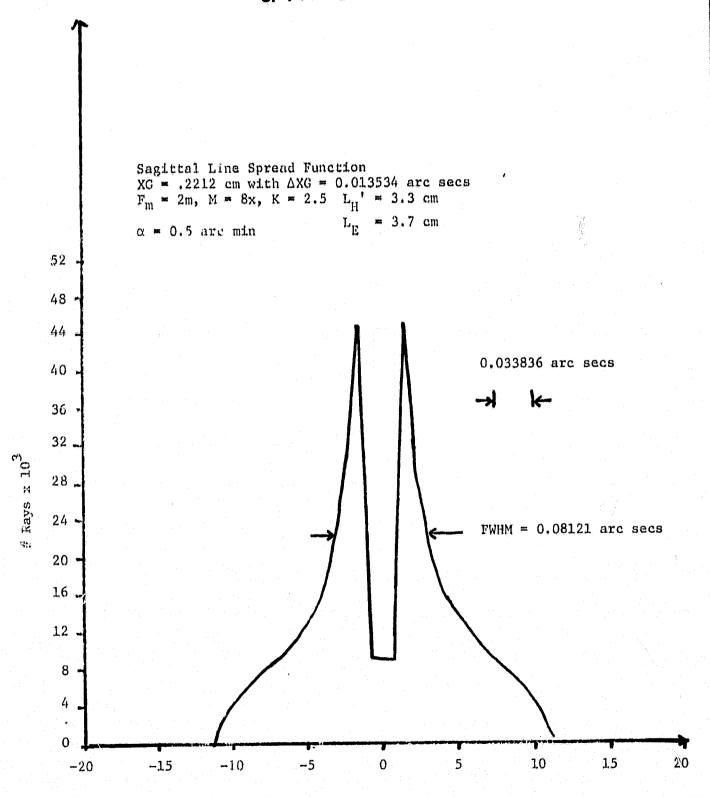


Fig. 34: Meridional Line Spread Function

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ΥG(μm)
Fig. 35: Sagittal Slice of Point Spread Function

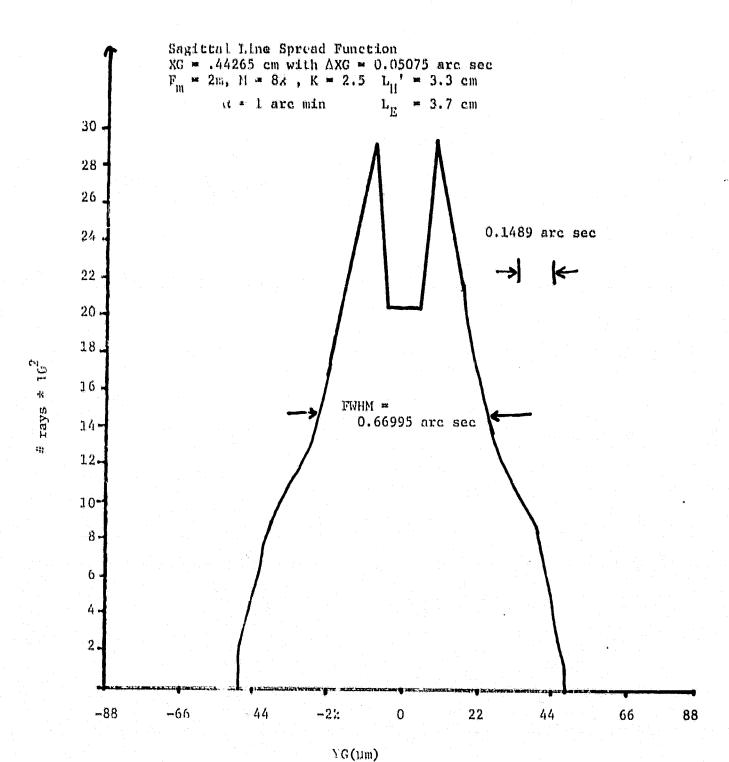


Fig. 36: Sagittal Slice of Point Spread Function

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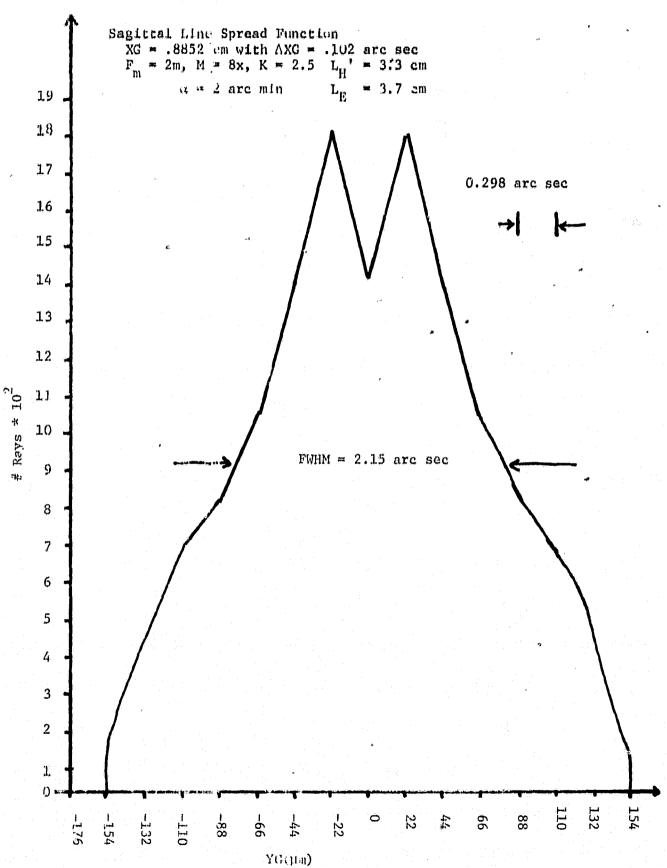
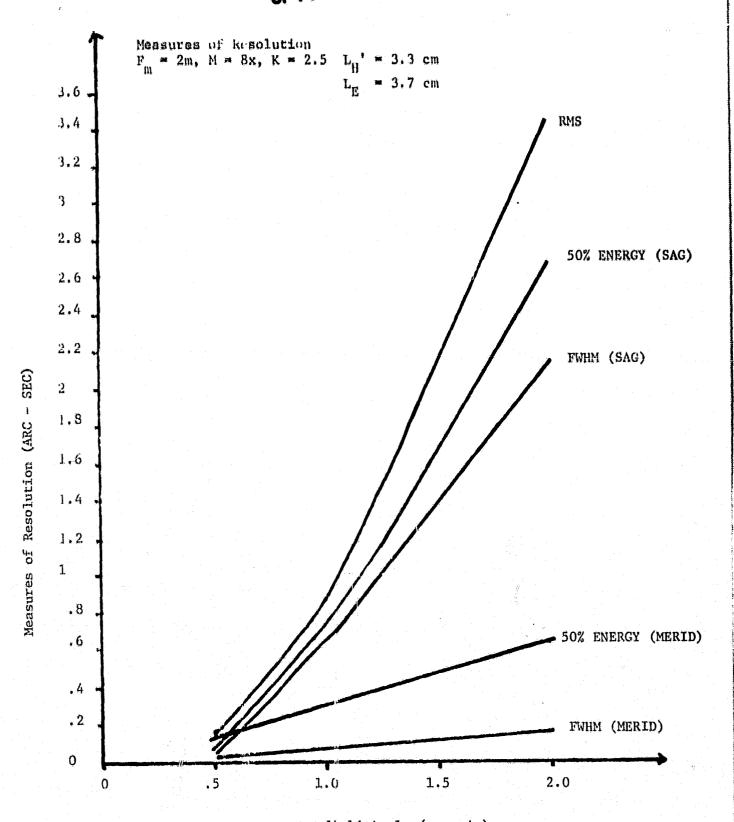


Fig. 37: Sagittal Slice of Point Spread Function

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α, Field Angle (arc min)

Fig. 38: Resolution vs Field Angle

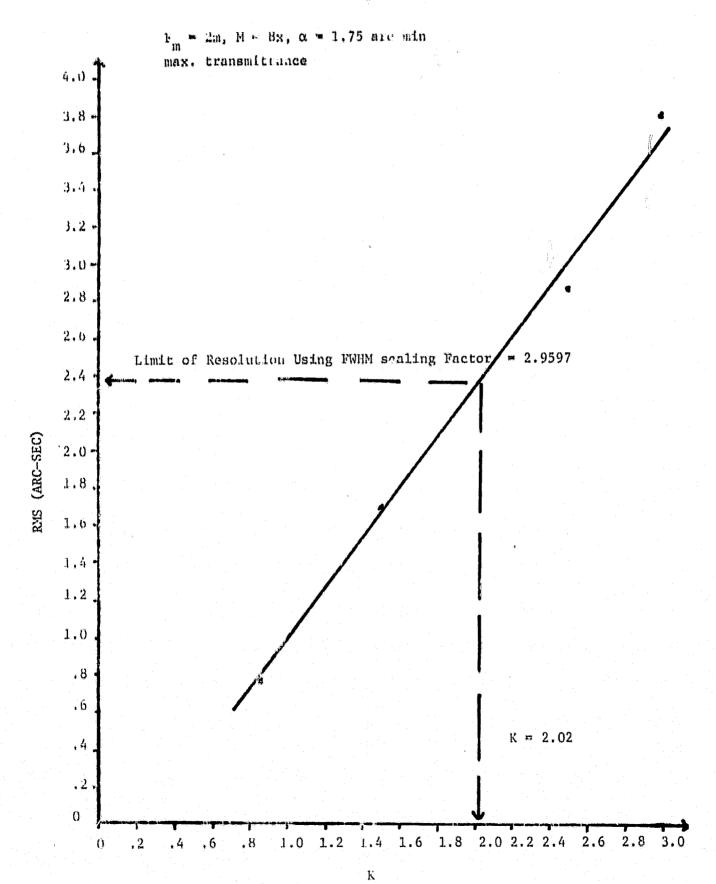
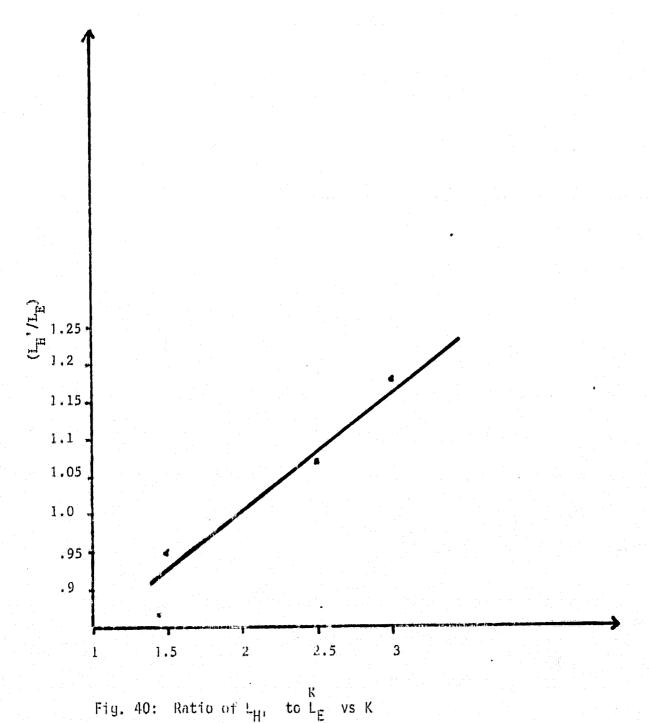


Fig. 39: RMS Spot Radius vs K

 $F_{in} = 2m$ , M = 8x,  $\alpha = 1.75$  are bitn Max Transmittance



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From (R  $_{15}$  ) and RPAR (R  $_{25}$  ) microscope aperture radii versus field angle.

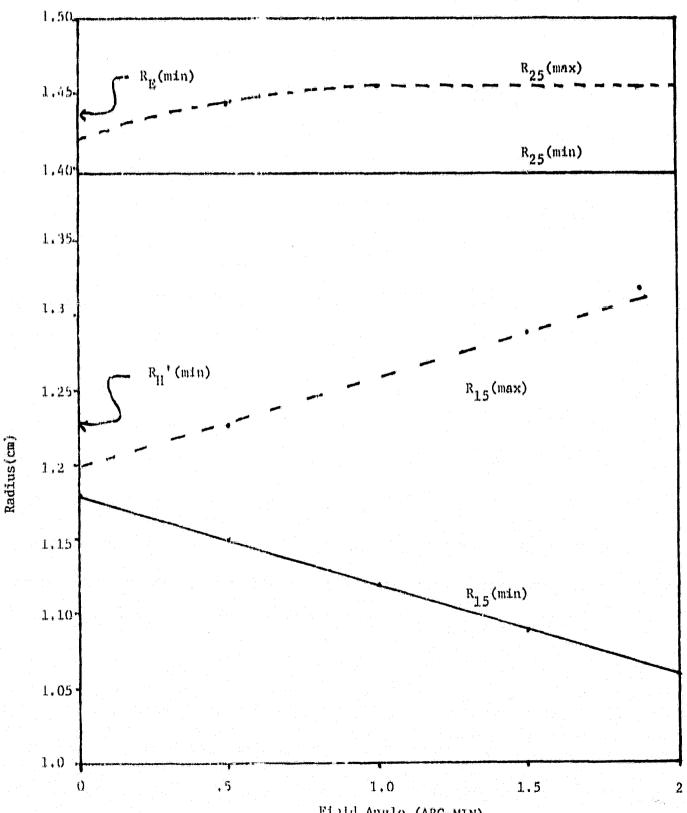


Fig.41: Aperture Radii vs Field Angle (ARC-MIN)